

SI defense: DE Cosmology &

Tests of DES Charge Coupled Devices

Treball de recerca de 3er cicle del programa de Doctorat en Física

sota la direcció del Dr. Ramon Miquel i el Dr. Manel Martínez

Lluís Galbany





DARK ENERGY
SURVEY

Outline

- DE introduction
- The Dark Energy Survey
- The SLAB
- DES CCDs
- Tests
- Conclusions



- DE -> Modern & unknown

DE ~ expansion

- Universe expanding

- Observational evidence from supernovae for an accelerating universe and a cosmological constant (A.Riess et al., 1998)
 - Measurements of Ω and Λ from 42 high redshift supernovae. (S. Perlmutter *et al.*, 1999)

They found that the expansion rate of the Universe is increasing with time studying type-Ia supernovae. 10-15% larger than expected

Something has to be taken into account...



- Einstein wanted a static universe.
GR don't permit it (Matter attracts gravitationally)
He added a term (cosmological constant) to arrange
a static UNI

$$R_{\mu\nu} - \frac{1}{2} R g_{\mu\nu} \boxed{-\Lambda g_{\mu\nu}} = 8\pi G T_{\mu\nu}$$

Hubble law -> expansion -> problem!

DE: we don't know what it is but it has to be there



The standard cosmological model

- **Cosmological principle:** Universe is isotropic and homogeneous (on large scales)
- **Metrics:** equation which gives the distance between two points
 - SR -> Minkowsky metric

$$ds^2 = -c^2 dt^2 + dr^2 + r^2 d\Omega^2$$

- GR -> Robertson-Walker metric

$$ds^2 = -c^2 dt^2 + a(t) \left[dr^2 + S_k(r)^2 d\Omega^2 \right]$$

t: cosmic time

r: comoving coordinates

a: scale factor -> expansion or contraction



Dynamics: relations between curvature & content

- **Friedmann equation.** Rel. among $a(t)$, k , $\varepsilon(t)$ & R_0

i: matter, radiation

$$H(t)^2 = \frac{\dot{a}(t)^2}{a(t)^2} = \left(\sum_i \frac{8\pi G}{3c^2} \varepsilon_i(t) \right) - \frac{kc^2}{R_0^2 a(t)^2}$$

- **Fluid equation.** Rel. among $a(t)$, $\varepsilon(t)$ & $P(t)$

$$\sum_i \dot{\varepsilon}_i + 3 \frac{\dot{a}}{a} (\varepsilon_i + P_i) = 0 \quad \longrightarrow \quad \varepsilon_i = \varepsilon_{i,0} a^{-3(1+w)}$$

- **Acceleration equation.** Rel. among $a(t)$, $\varepsilon(t)$ & $P(t)$

$$\frac{\ddot{a}}{a} = \sum_i - \frac{4\pi G}{3c^2} (\varepsilon_i + 3P_i)$$

- **Equation of state.** Rel. between $\varepsilon(t)$ & $P(t)$

$$P_i = w_i \varepsilon_i \quad \text{where } w_i < 1$$



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DARK ENERGY
 $w_{DE} < -1/3$

Λ
 $w_\Lambda = -1$



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$$\Omega_i = \frac{\varepsilon_i}{\varepsilon_c}$$

- **Fluid equation.** Rel. among $a(t)$, $\varepsilon(t)$ & $P(t)$

$$\frac{H^2(a)}{H_0^2} = \frac{\Omega_M}{a^3} + \frac{\Omega_R}{a^4} + \frac{\Omega_{DE}}{a^{3(1+w)}} + \frac{1-\Omega_o}{a^2}$$

$$\sum_i \dot{\varepsilon}_i + 3 \frac{\dot{a}}{a} (\varepsilon_i + P_i) = 0 \longrightarrow \varepsilon_i = \varepsilon_{i,0} a^{-3(1+w)}$$

- **Acceleration equation.** Rel. among $a(t)$, $\varepsilon(t)$ & $P(t)$

$$\Lambda = -\frac{8\pi G}{c^2} \varepsilon$$

$$\frac{\ddot{a}}{a} = \sum_i -\frac{4\pi G}{3c^2} (\varepsilon_i + 3P_i) + \frac{\Lambda}{3}$$

- **Equation of state.** Rel. between $\varepsilon(t)$ & $P(t)$

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New component

- $\Lambda \sim \text{fluid}$
- Λ has a negative effective pressure.

$$P_\Lambda = -\varepsilon_\Lambda = -\frac{c^2}{8\pi G} \Lambda$$

As UNI expands, work is done on Λ fluid. $\rightarrow E_\Lambda$ remains constant

$$W = -\int P dV \quad \longrightarrow \quad \text{Energy of the empty space (vacuum)}$$

- Classical physics
 - (“Nothing can come from nothing.” King Lear)
- Quantum physics
 - Fluctuations satisfying $\Delta E \Delta t \geq h$

E associated
to the virtual
particles

$$\varepsilon_{VAC} \sim \frac{E_P}{l_P^3} \approx 3 \times 10^{133} eV \times m^{-3} \sim 10^{124} \varepsilon_{critical}$$

Theory and
observations
don't match



DE >> gravity

- Universe only with Λ (or Λ -dominated)

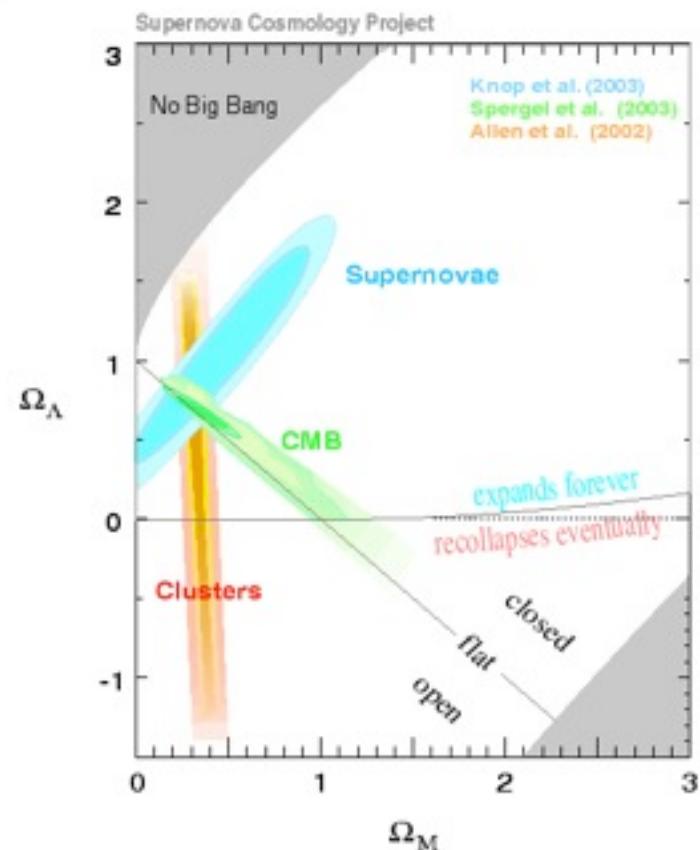
Friedmann equation

$$\dot{a}^2 = \frac{8\pi G \epsilon_{\Lambda}}{3c^2} a^2 \quad \longrightarrow$$

$$a(t) = e^{H_0(t-t_0)}$$

Universe exponentially expanding

Infinitely old, infinite horizon distance





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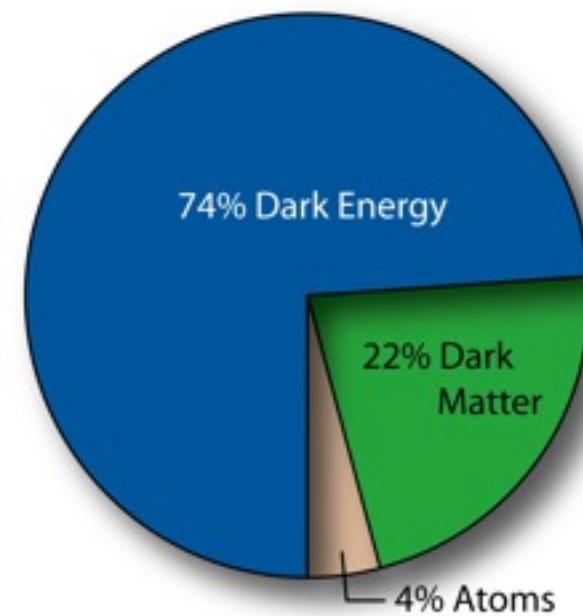
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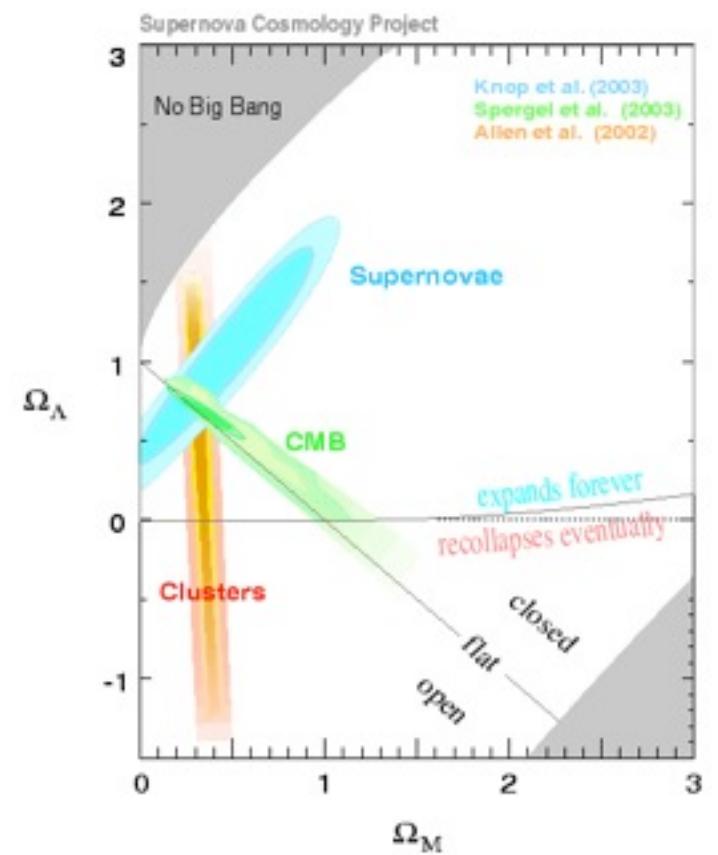
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Infinitely old, infinite horizon distance



The best model is

$$\Omega_M \approx 0.3$$
$$\Omega_\Lambda \approx 0.7$$





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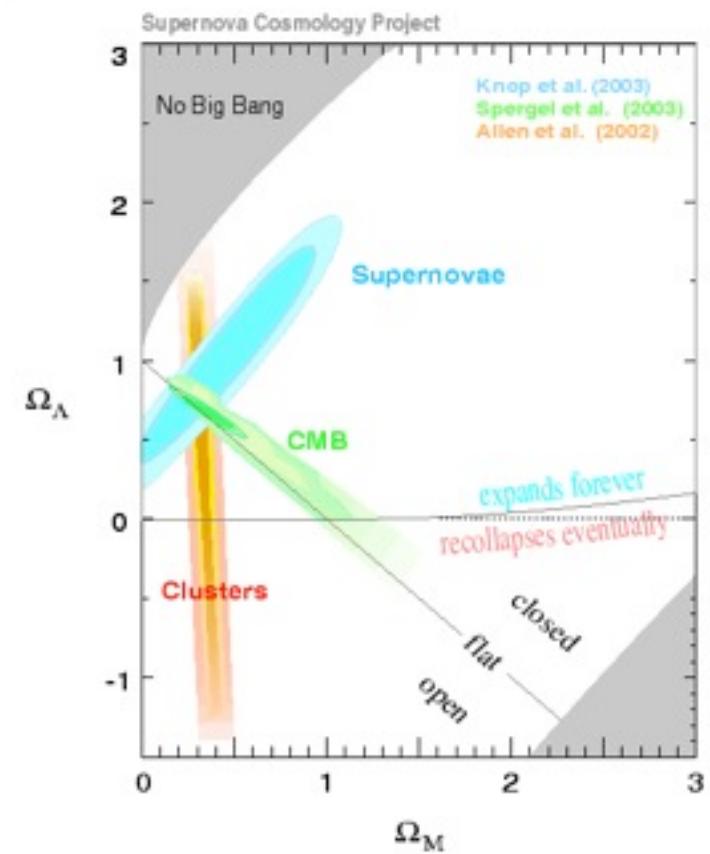
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The best model is

$$\Omega_M \approx 0.3$$

$$\Omega_\Lambda \approx 0.7$$





DE is not...





DE is not...

What can be?



- Transient phenomenon, which will disappear in the future
- Cosmological constant (Λ CDM model)
- Scalar field (quintessence). Λ is not constant, exhibits slow variation
- Modified gravity (Gauss-Bonet: extradimensions)



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The Dark Energy Survey



- Optical & NIR survey
- Dark energy properties

$$P_{DE} = w\varepsilon_{DE}$$

- 4m Blanco telescope (CTIO-NOAO)





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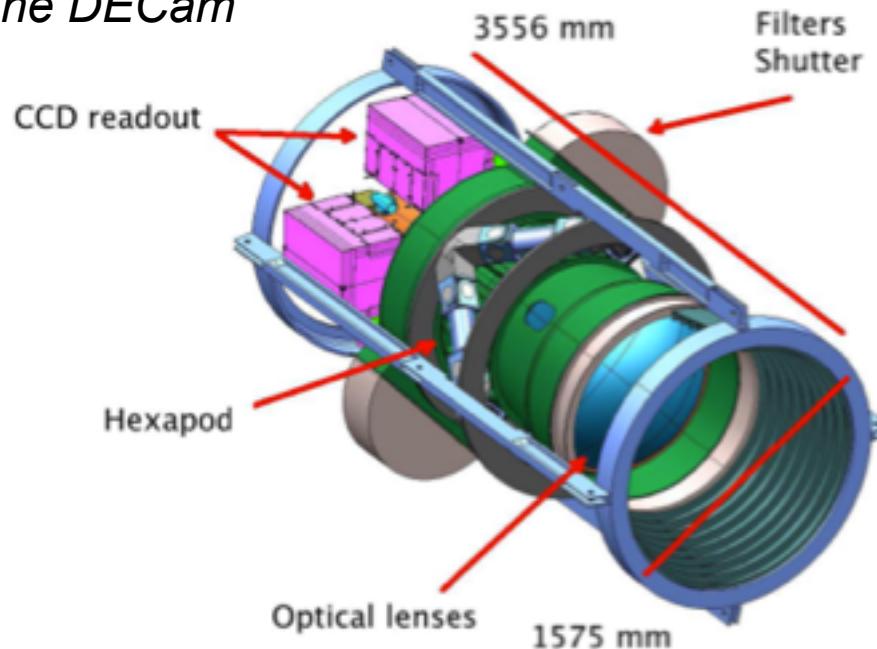
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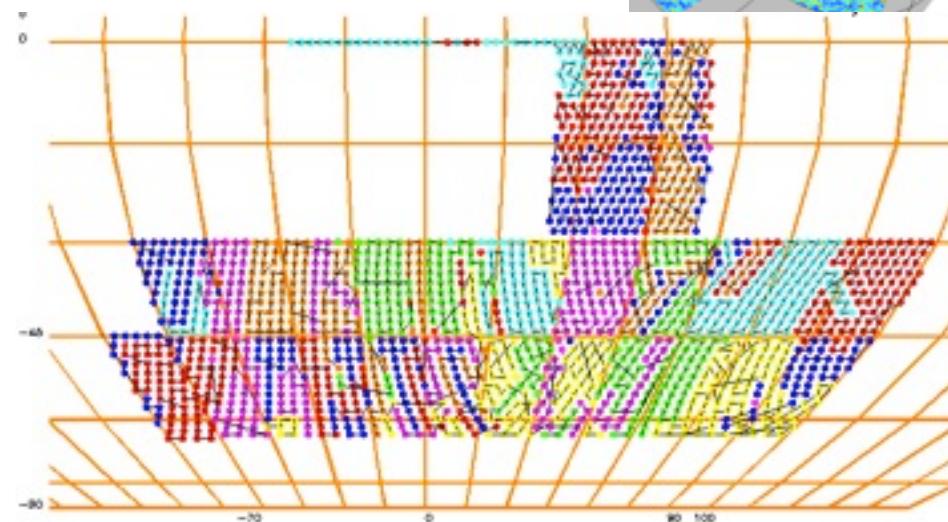
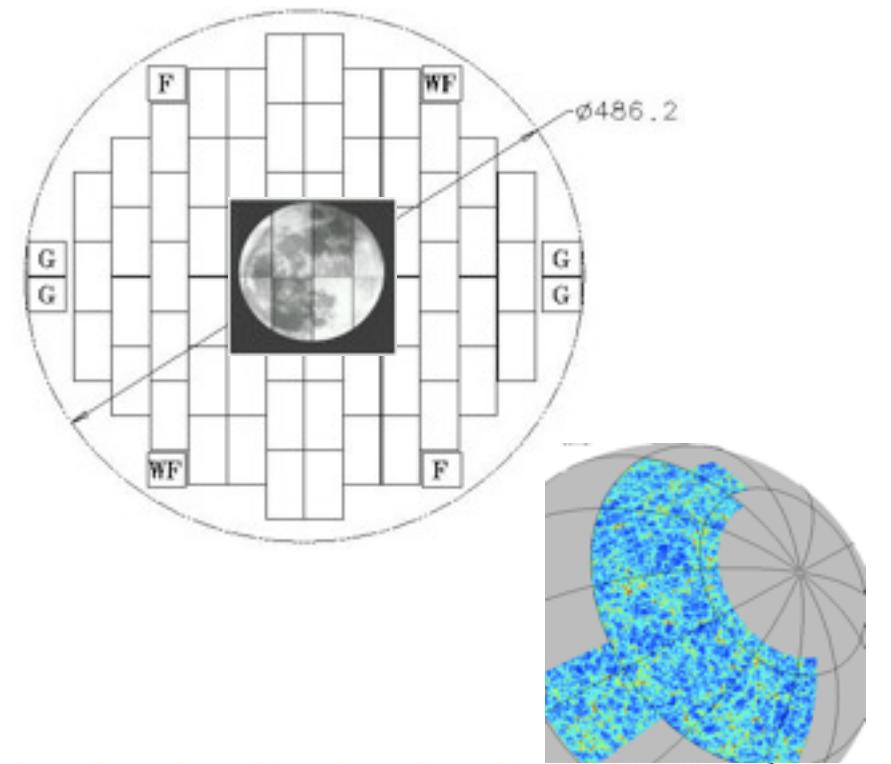


The Dark Energy Survey

The DECam



- CCD mosaic camera
 - 3 sq deg field of view
 - **62 LBNL CCDs (4k x 2k pixels)**
 - griZY filters
 - 5000 sq deg
- 300 milion galaxies
15000 clusters
1200 SNIa

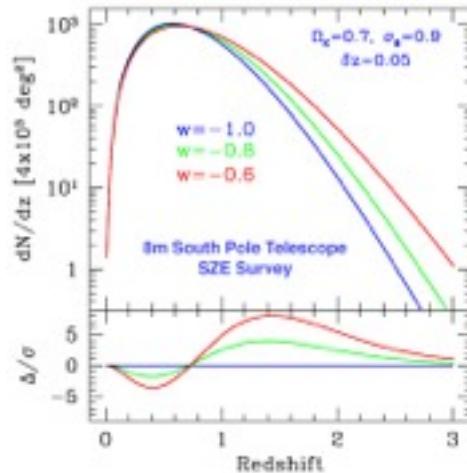




DES techniques

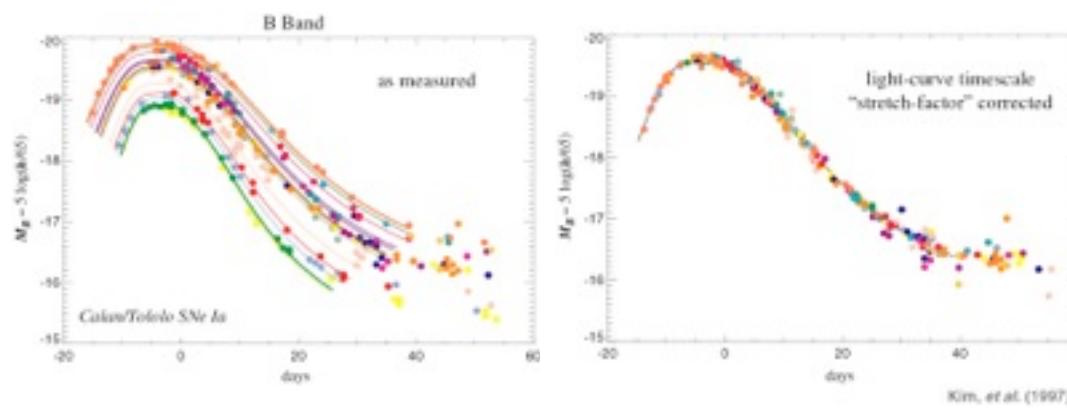
Galaxy clusters redshift distribution

Galaxy cluster density mass function (SPT)



Weak lensing

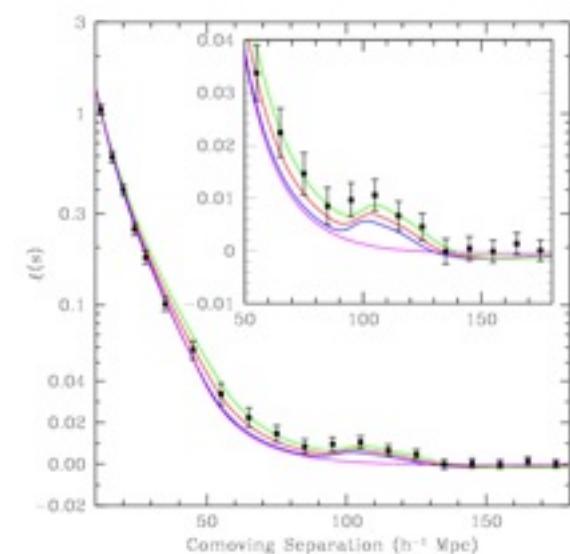
Evolution of the distortions pattern



SNelA: Distance to standard candles

Correlation Vs redshift

Baryon acoustic oscillations

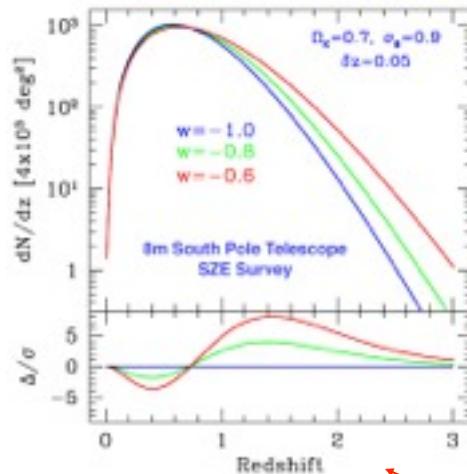




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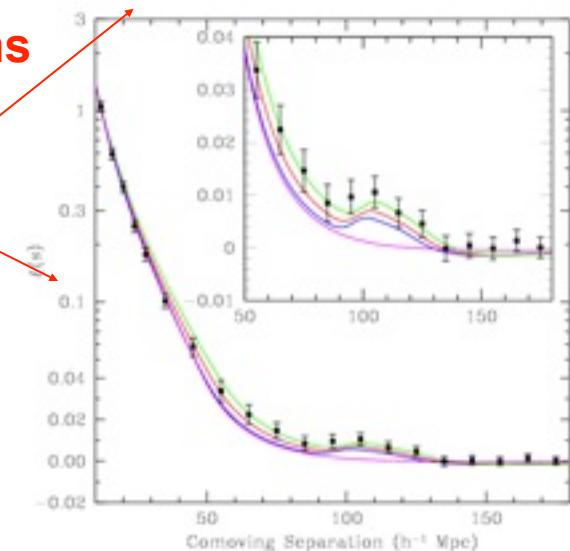
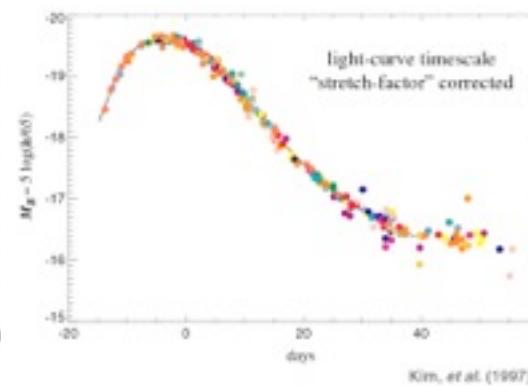
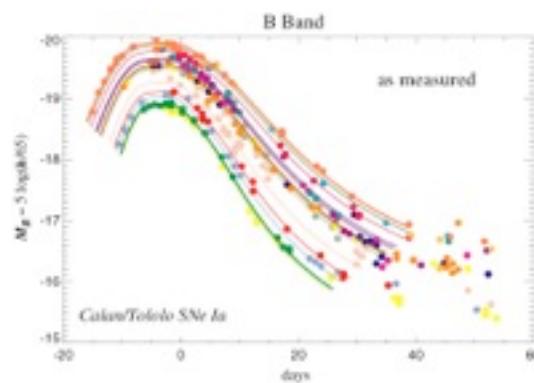
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Evolution of the distortions pattern



Growth of density perturbations

Geometry of the Universe



Correlation Vs redshift

Baryon acoustic oscillations

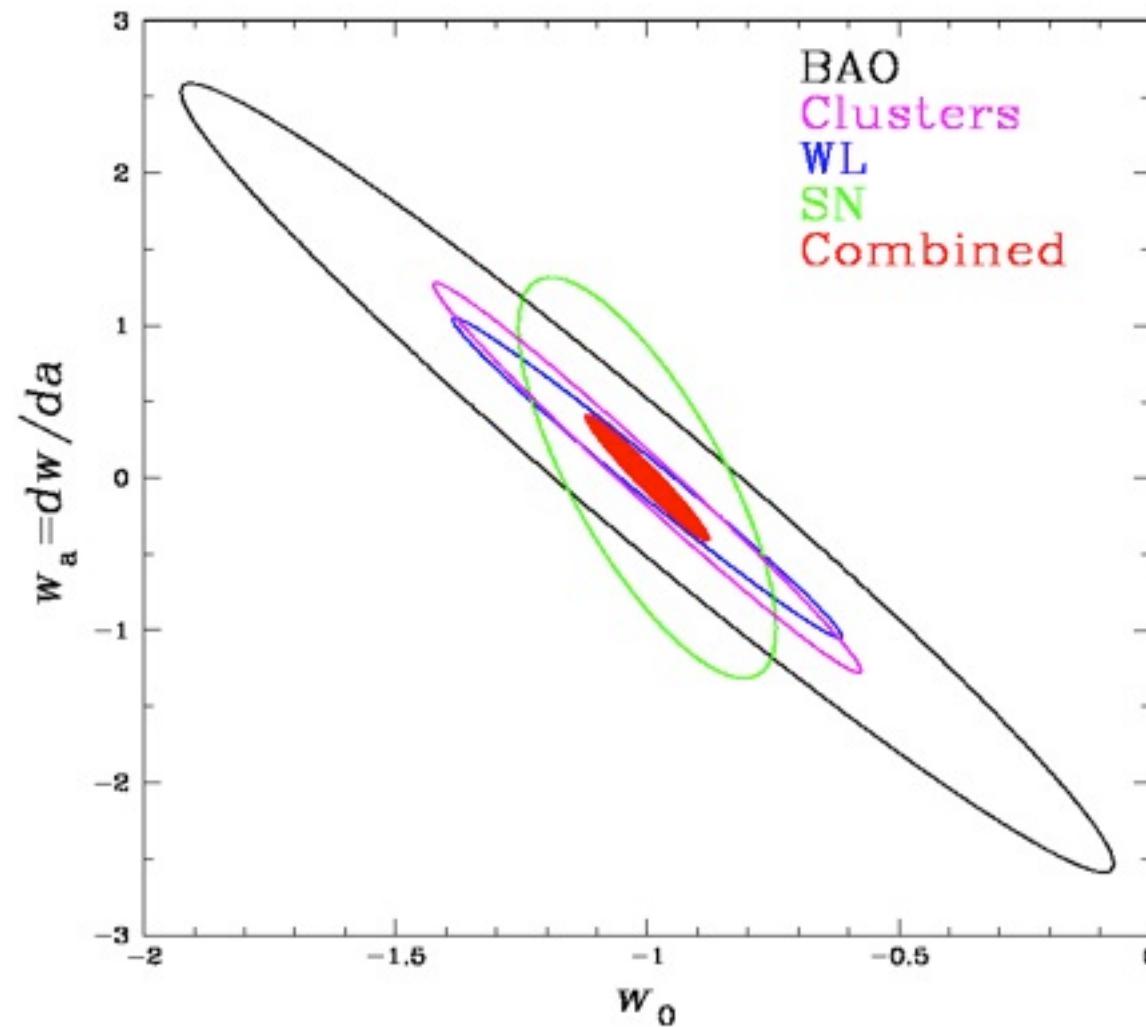
SN Ia: Distance to standard candles



DES techniques

$$w(z) = w_0 + w_a(1-a) = w_0 + w_a \frac{z}{1+z}$$

$$a = \frac{1}{1+z}$$

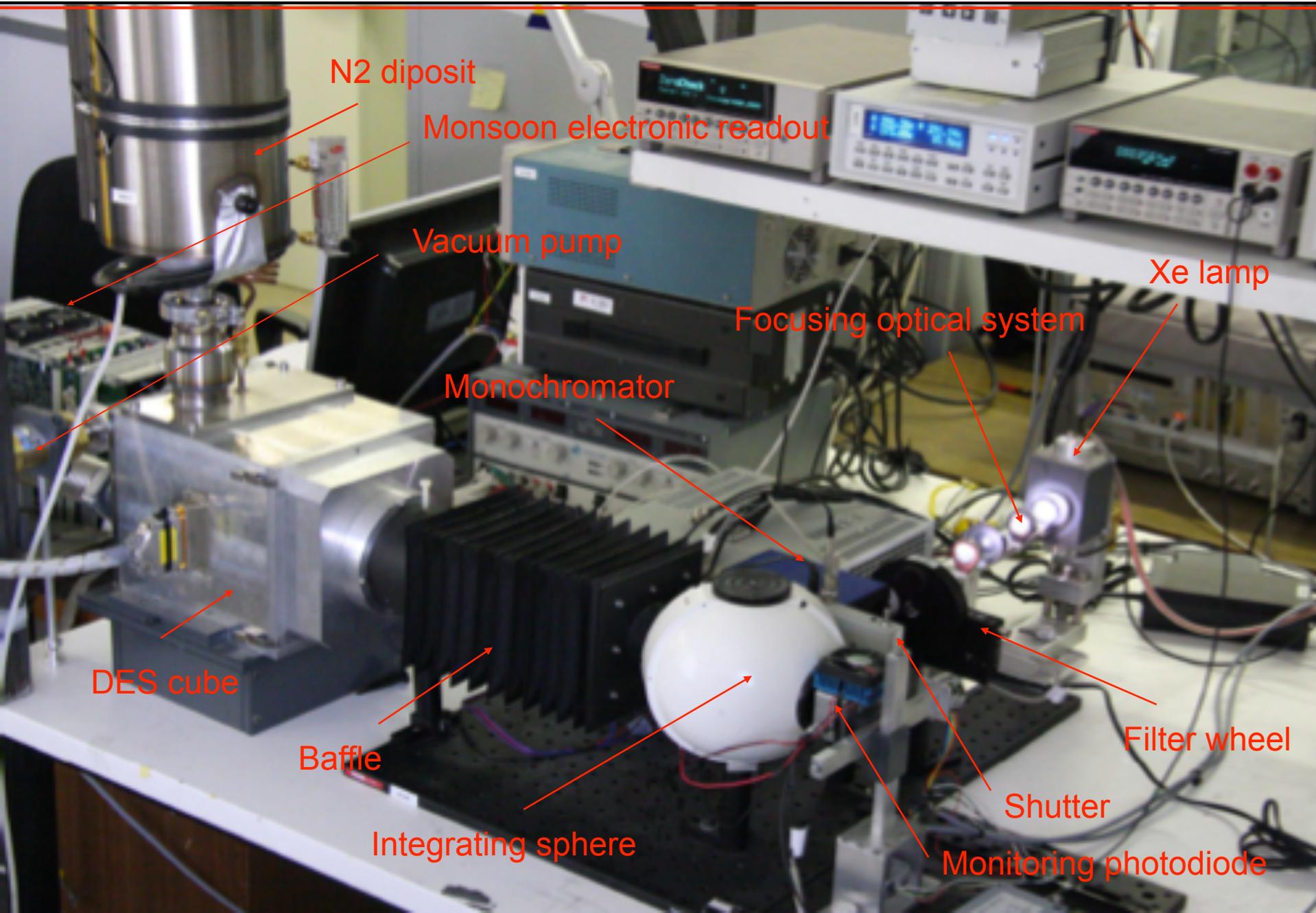




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Integrating sphere characterization

$$I(x, y) = I_0 \cos^4(\theta)$$

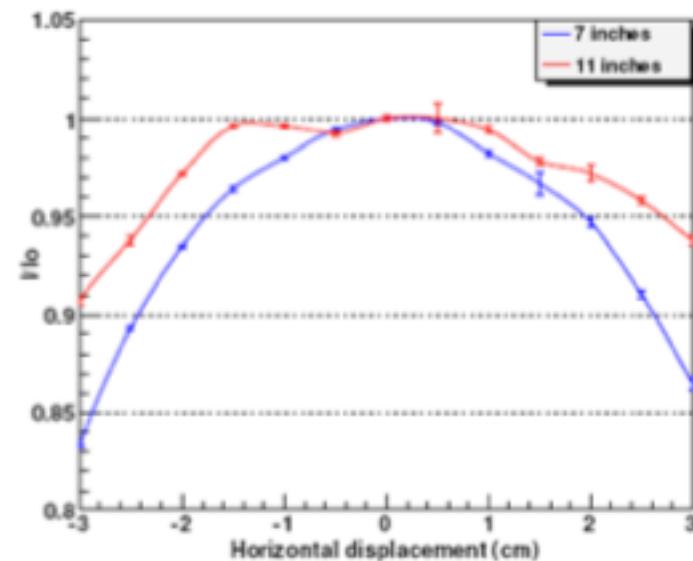
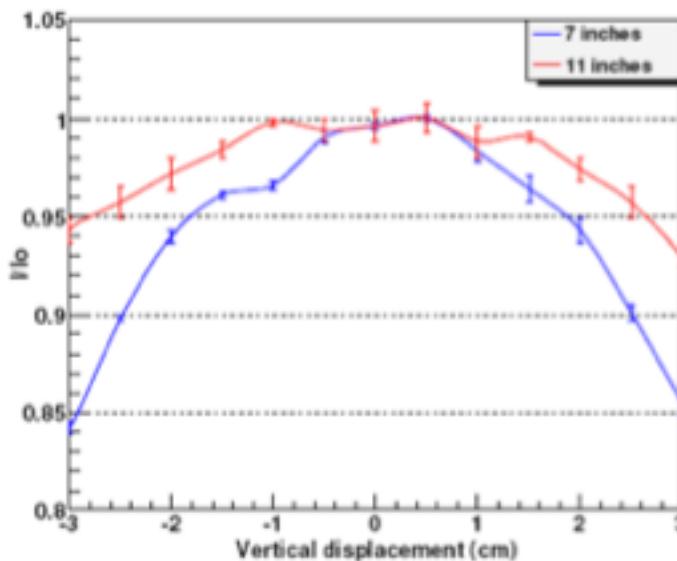
- We used a photodiode (light intensity to electrical intensity)
- Measurements of the uniformity at different distances from the sphere
- 6cm transversally. Steps of 0.5cm



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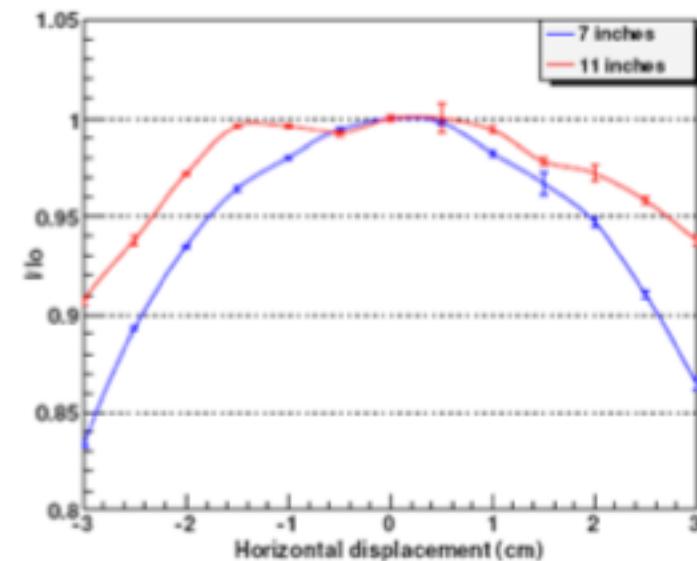
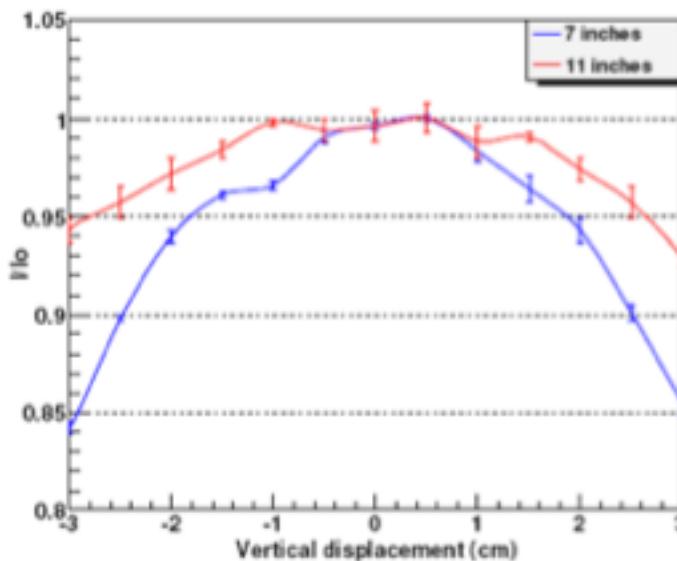


x (in)	d = -3 cm	-2 cm	-1 cm	0 cm	1 cm	2 cm	3 cm
7	0.84	0.94	0.98	1.00	0.98	0.94	0.86
11	0.93	0.97	0.99	1.00	0.98	0.97	0.94
14	0.96	0.97	0.99	1.00	0.99	0.97	0.96



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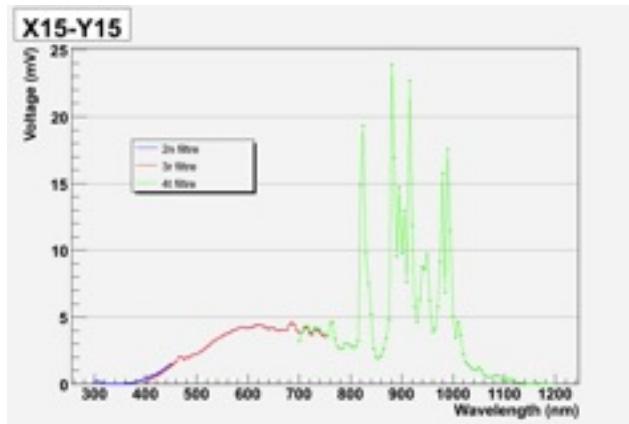
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The farther the photodiode is from the sphere, the better uniformity provides

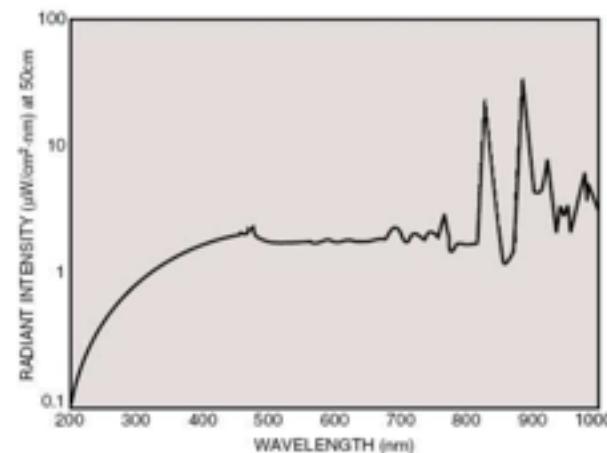


Uniformity maps

measured spectrum



manufacturer spectrum



6cm x 6cm
surface

At 13 inches
from sphere

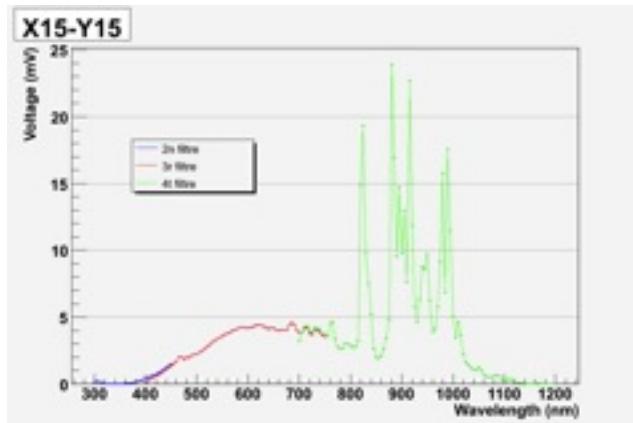
From 300 to
1100nm

Every 5nm

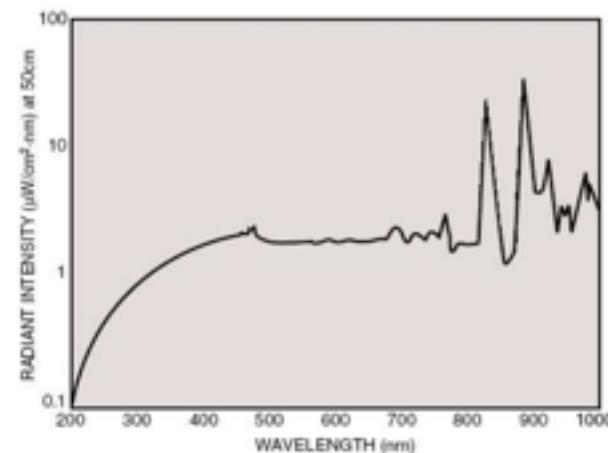


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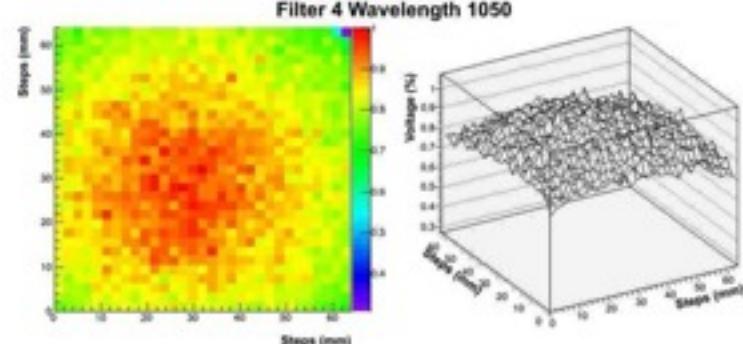
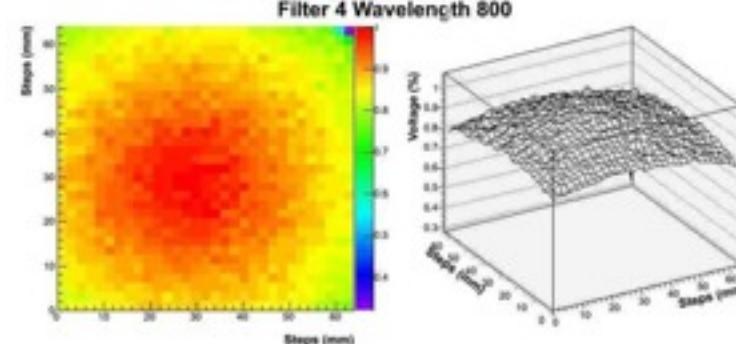
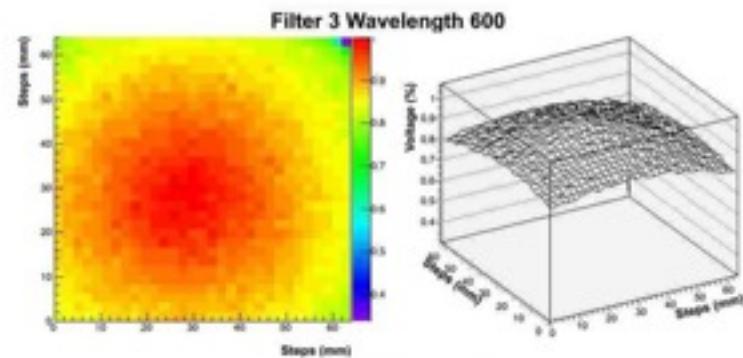
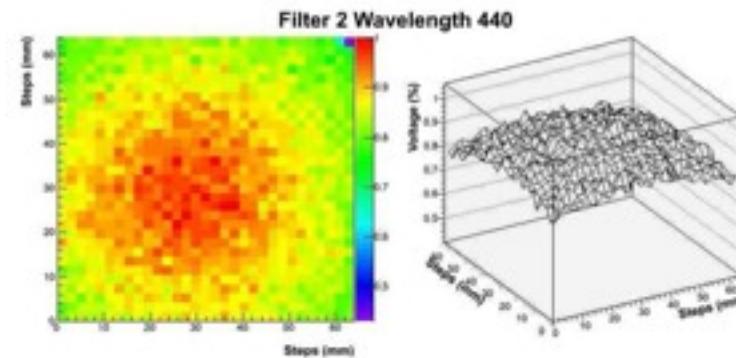


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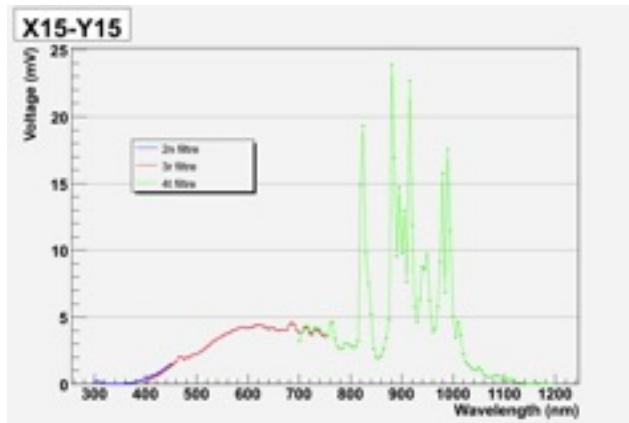
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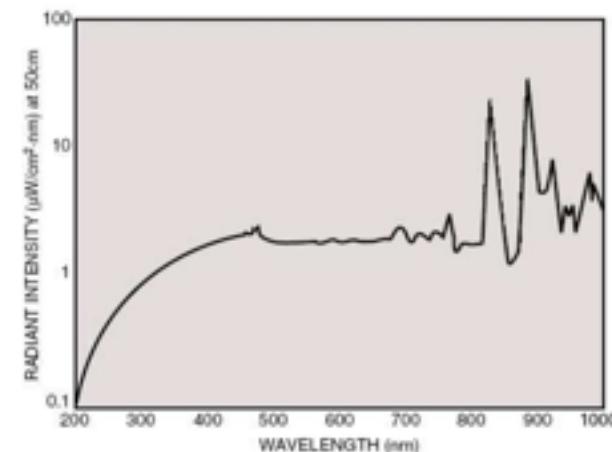


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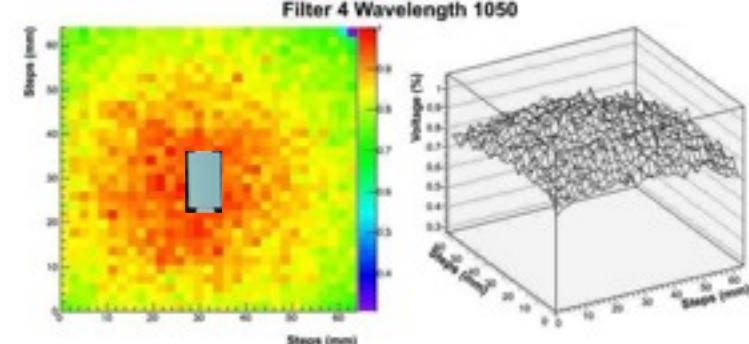
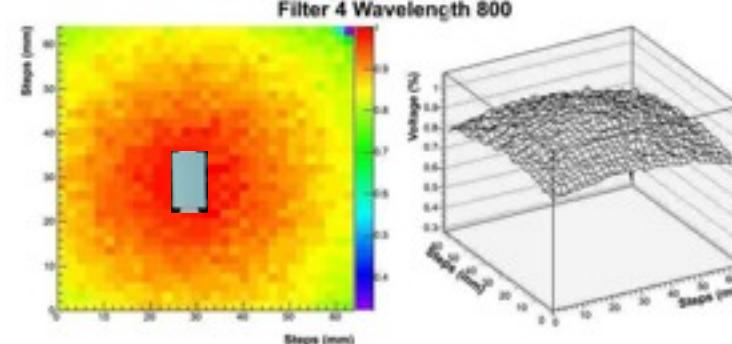
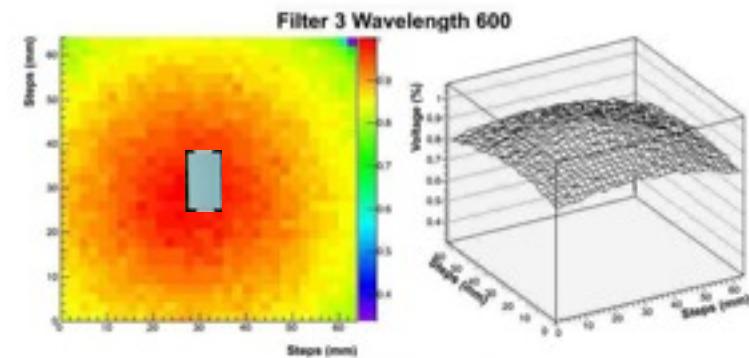
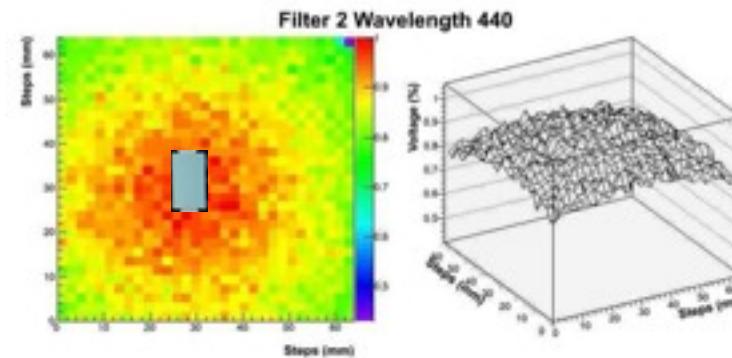


6cm x 6cm surface

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Characterization in absolute number of photons

- Absolute calibration in number of photons
- Photodiode in the other output sphere port
- Loss between the light emitted and the light detected
 - This relative measurement is necessary to measure the QE in the future

$$R(\nu) = \frac{I_P(\nu)}{I_{CCD}(\nu)}$$

$$QE = \frac{p_{\text{int}}}{p_0 R(\nu)}$$



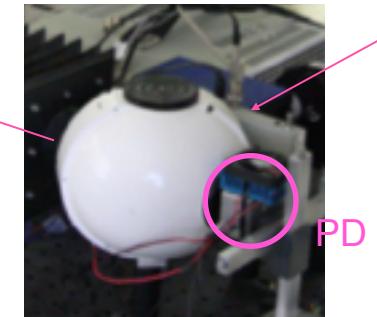
Characterization in absolute number of photons

From the lamp

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To the cube



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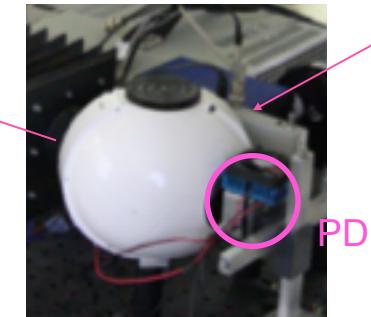


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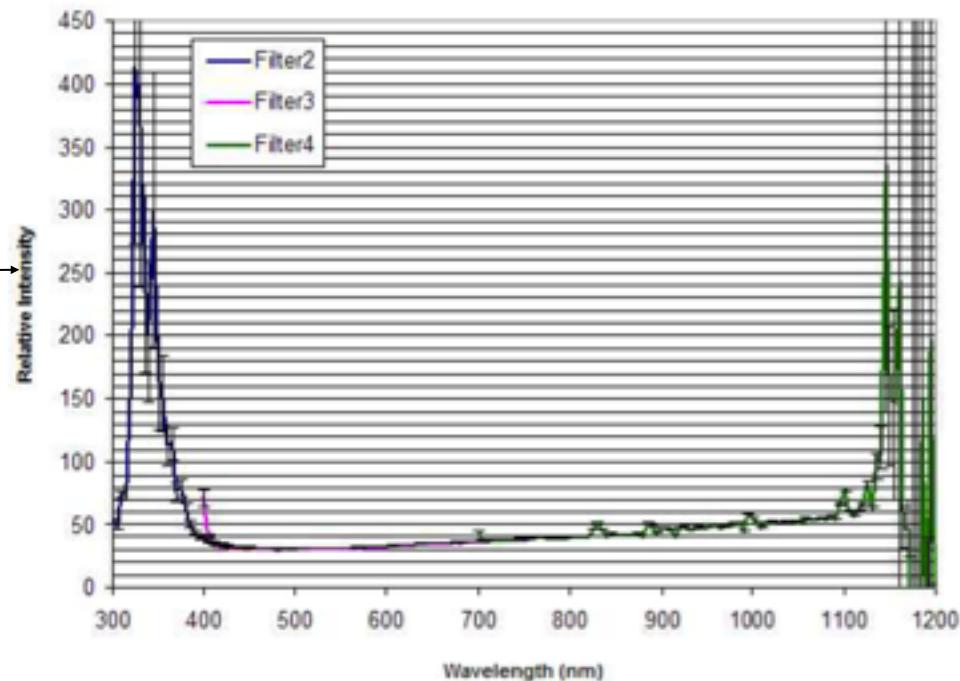
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Coating (BaSO) does not integrate all the wavelengths in the same way



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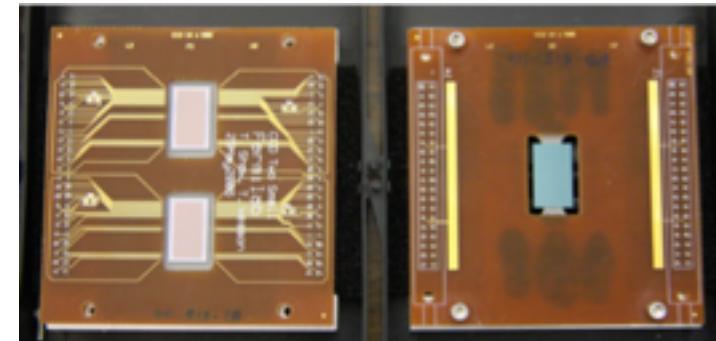
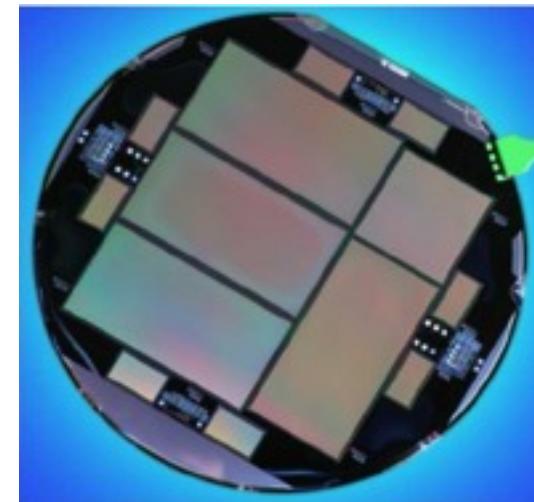
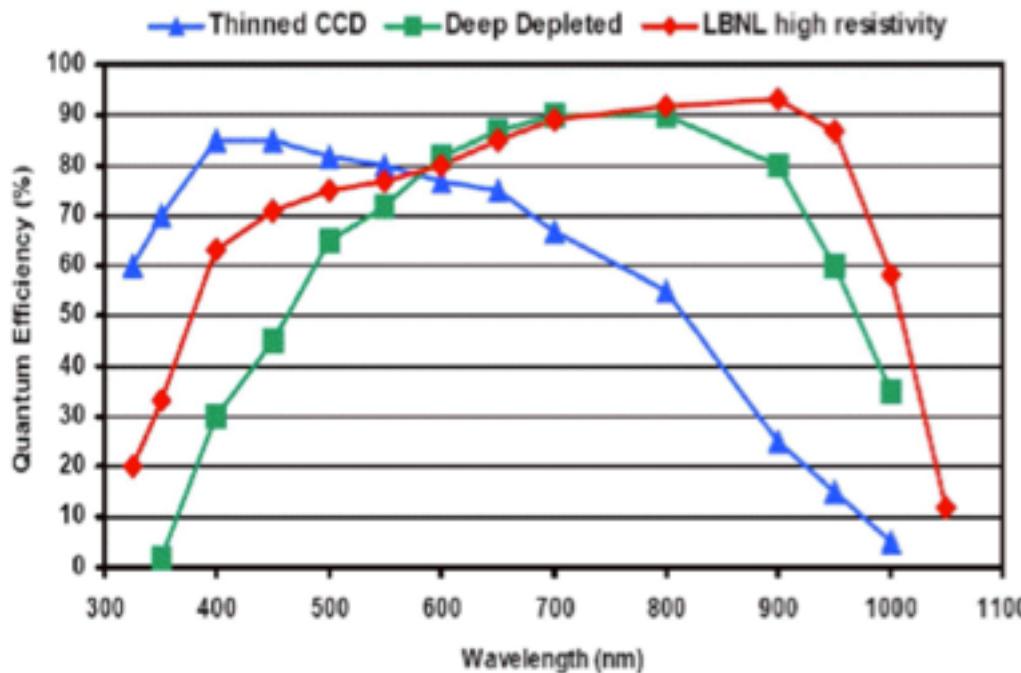
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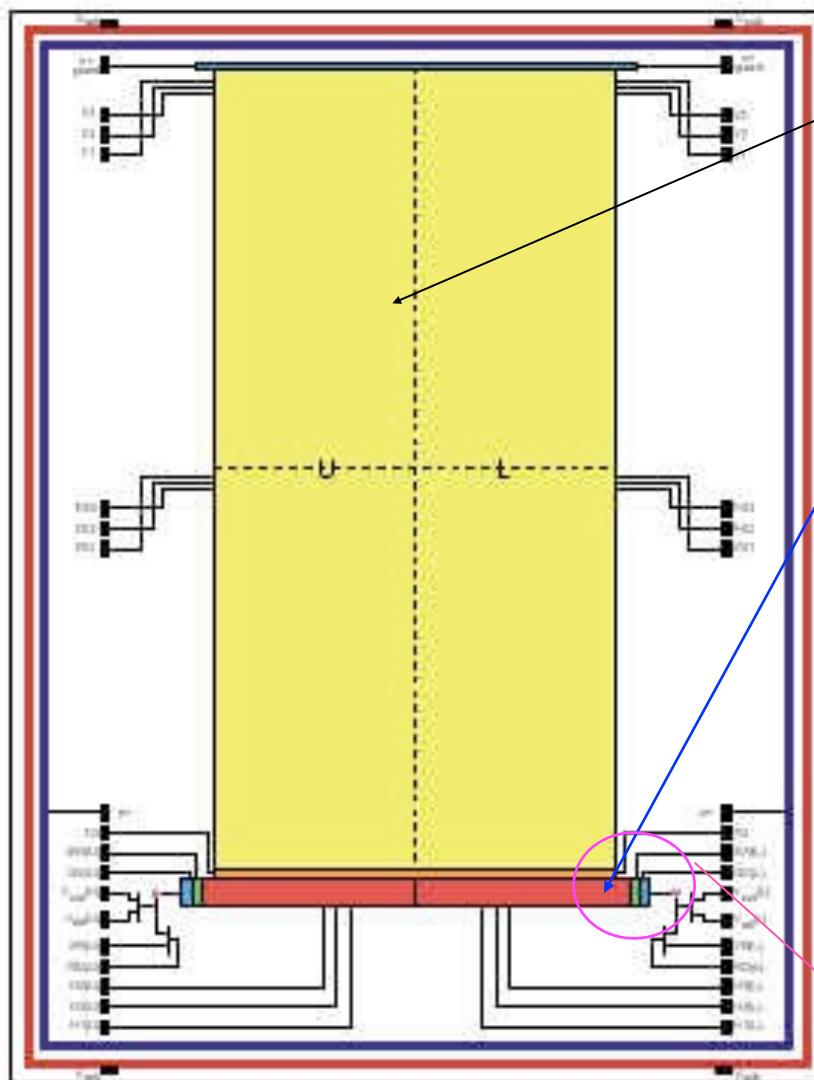
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LBNL Design

- Sizes: 2kx4k, 2kx2k, 0.5kx1k
- 250 μm thick
- 15 μm pixels (0.27"/pixel)
- readout 250 kpix/sec, readout time ~17sec
- QE > 50% at 1000 nm



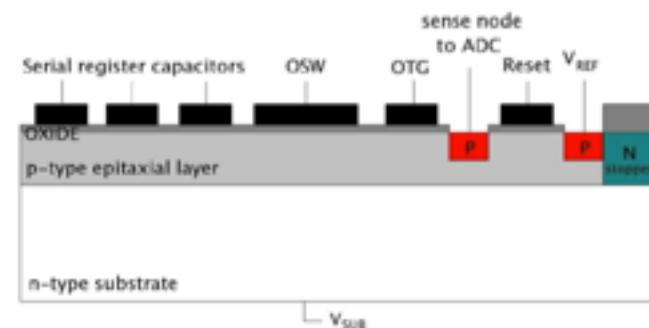
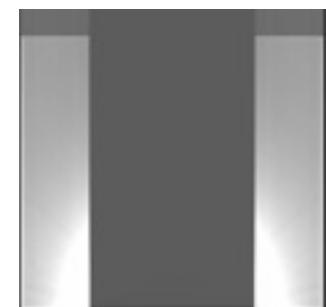


Vertical clocking moves charge towards serial register

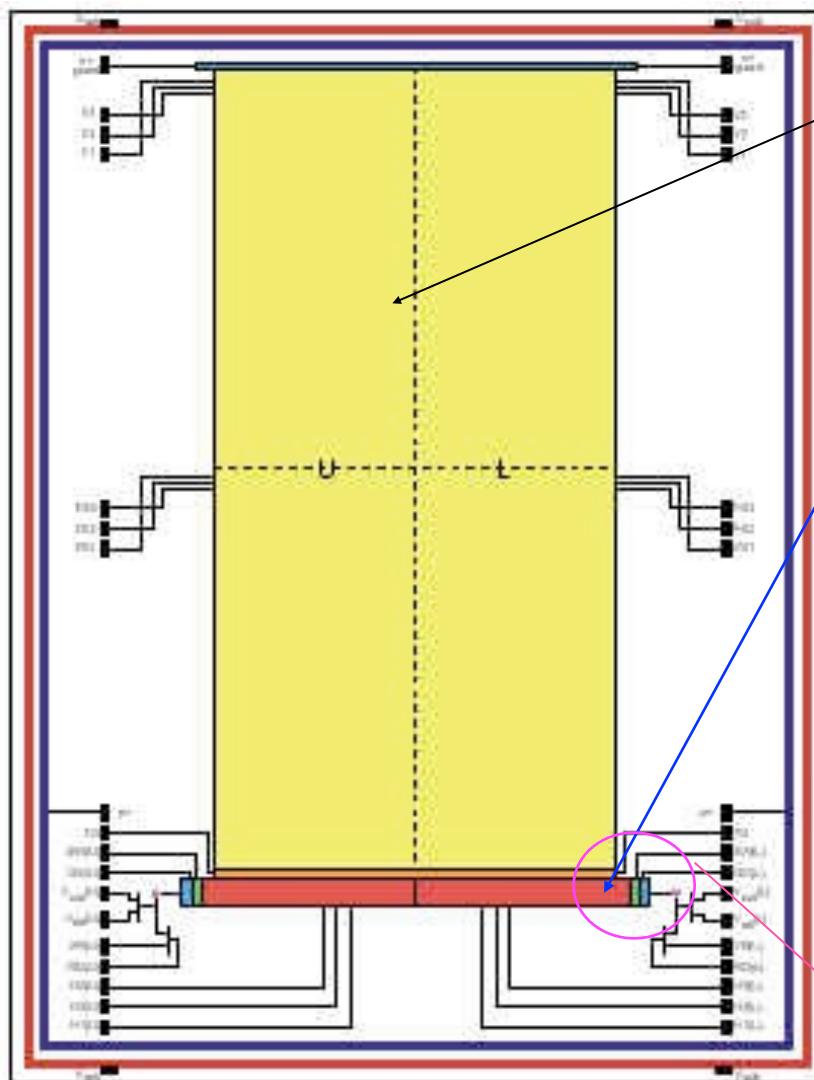
Horizontal clocking moves charge along serial output register to video output amplifiers

2 channels (U,L) to read each half part of the CCD

Over clocks are done to measure the dark current



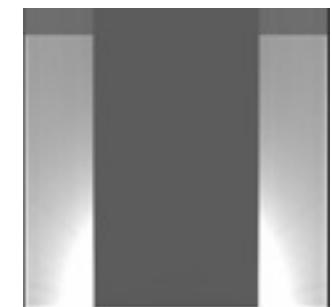
Last gates of the serial register



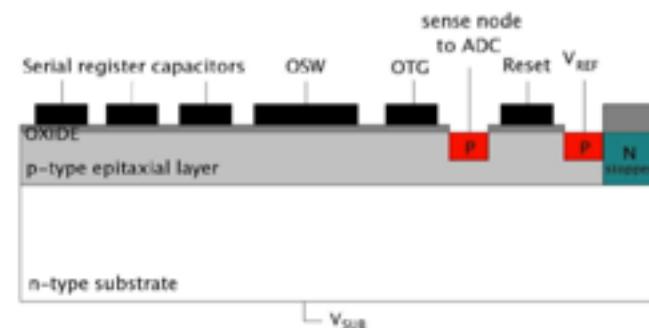
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Bias voltages table provided by LBNL

<i>Signal</i>	<i>Typical voltage (V)</i>
Substrate bias (V_{SUB})	40
Reset drain (V_{REF})	-12
Output transfer gate (V_{OTG})	3.5
Vertical clocks (V_1, V_2, V_3)	5.5, -2.5, 5.5
Horizontal clocks (H_1, H_2, H_3)	8.5, -3.5, 8.5
Output Summing well (V_{OSW})	-4

Charge is accumulated and a reading is done

- Clear image: to empty the wells
- Exposed image: shutter open
- Non-exposed image: shutter closed
- Reading: the transfer process starts

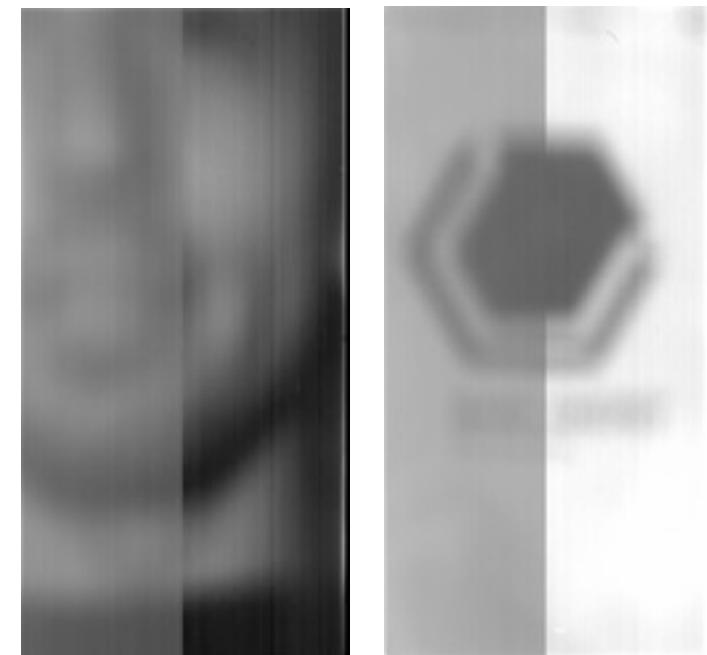


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Reset drain (V_{REF})	-12
Output transfer gate (V_{OTG})	3.5
Vertical clocks (V_1, V_2, V_3)	5.5, -2.5, 5.5
Horizontal clocks (H_1, H_2, H_3)	8.5, -3.5, 8.5
Output Summing well (V_{OSW})	-4

Charge is accumulated and a reading is done

- Clear image: to empty the wells
- Exposed image: shutter open
- Non-exposed image: shutter closed
- Reading: the transfer process starts





DARK ENERGY
SURVEY

Outline

- DE introduction
- The Dark Energy Survey
- The SLAB
- DES CCDs
- Tests
- Conclusions



CCD performance functions

Charge generation

ability to intercept an incoming photon through the photoelectric effect

Charge collection

ability to reproduce an image from the electrons collected

Charge transfer

ability to transfer collected charge from one potential well to another

Charge measurement

ability to detect and measure the charge collected in each pixel

Parameter	Test	Task
Dark count	PTC	Charge generation
Linearity	PTC	Charge measurement
Full-well capacity	PTC	Charge collection
Amplifier's gain	PTC	Charge measurement
Pedestal	PTC	Charge collection
Amplifier's gain	MUON	Charge measurement
Diffusion	MUON	Charge collection
Charge transfer efficiency	MUON	Charge transfer
Energy Vs ADU	MUON	Charge measurement
Amplifier's noise	NOISE	Charge measurement
Charge transfer efficiency	CTI	Charge transfer
Charge transfer efficiency	XRAY	Charge transfer
Energy Vs ADU	XRAY	Charge measurement

	LBNL CCD performance	DES requirements
Pixel array	2048 × 4096 pixels	2048 × 4096 pixels
Pixel size	15 μm × 15 μm	15 μm × 15 μm
<QE (400-700 nm)>	~70%	>60%
<QE (700-900 nm)>	~90%	>80%
<QE (900-1000 nm)>	~60%	>50% at 1000 nm
Full well capacity	170,000 e ⁻	>130,000 e ⁻
Dark current	2 e ⁻ /hr/pixel at -150°C	<~25 e ⁻ /hr/pixel
Persistence	Erase mechanism	Erase mechanism
Read noise	7 e ⁻ @ 250 kpix/s	< 10 e ⁻ @ 250 kpix/sec
Charge Transfer Inefficiency	< 10 ⁻⁶	< 10 ⁻⁵
Charge diffusion	6 μm	< 7 μm (*)
Linearity	Better than 1%	1%



- Automatic Tcl/Tk script to take the images for the tests (*MecStart*).
- 826 FITS images stored in the DES computer
 - Images:
 - Otg 140 images
 - Votgscan 196 images
 - Ptc 320 images
 - Noise 10 images
 - Cti 160 images
 - Other tests:
 - Xray about 100
 - Muon about 100
- A Linux script distribute the FITS in folders for each test, and execute the analysis tools
- Useful regions of FITS images are converted to text files with the ADUs of the pixels
- The results are plotted using ROOT
- At the end, a LaTeX review is automatically generated



Tests

- Automatic Tcl/Tk script to take the images for the tests (*MecStart*).
- 826 FITS images stored in the DES computer

CCD Testing Report

Device ID	pb-512-19
Type	Back Illuminated
Size	1024x512
Thickness	250 μm
Operator	Lluís Galbany
Analysis	Lluís Galbany

Results Analysis:

	Right Amp. (RH)	Left Amp. (LH)
Gain (ADU/e)	1.223 ± 0.000	3.118 ± 0.000
Noise (ADU)	12.410 ± 0.023	11.267 ± 0.020
Full Well Capacity(e)	~ 180000	~ 180000
Nonlinearity > 1% (s)	12 ± 1	9 ± 1
Output Gate for Charge Inj. Vref=-12V (V)	2.6 ± 0.1	2.1 ± 0.1
Minimal H+ for CTI requirements (V)	5.5 ± 0.5	6.0 ± 0.5
Minimal H- for CTI requirements (V)	-10.0 ± 0.5	-10.0 ± 0.5
Minimal V+ for CTI requirements (V)	1.0 ± 0.5	1.0 ± 0.5
Minimal V- for CTI requirements (V)	-10.0 ± 0.5	-10.0 ± 0.5
CTI calculus from Fe ⁵⁵ source	$3.13 \cdot 10^{-6}$	$4.01 \cdot 10^{-7}$

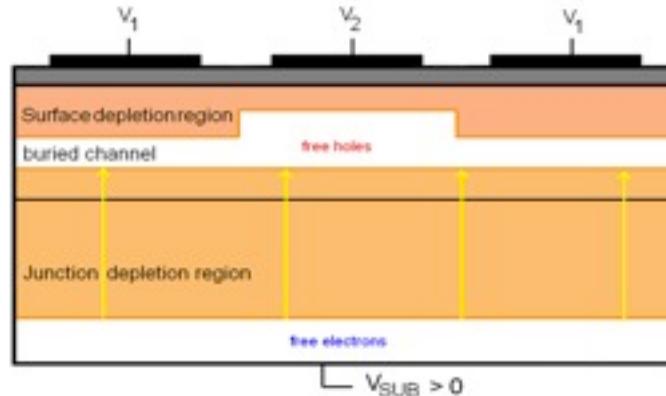
- Images:
 - Otg 140 images
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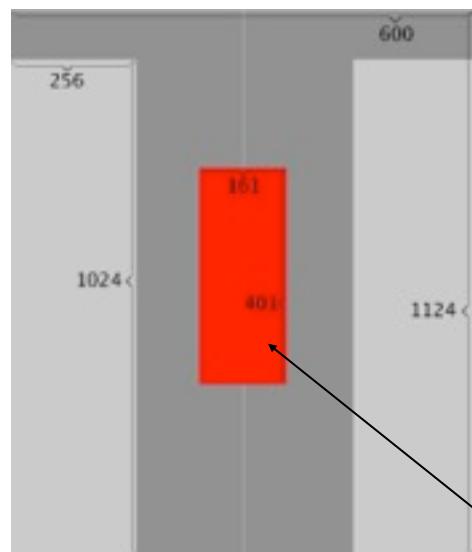
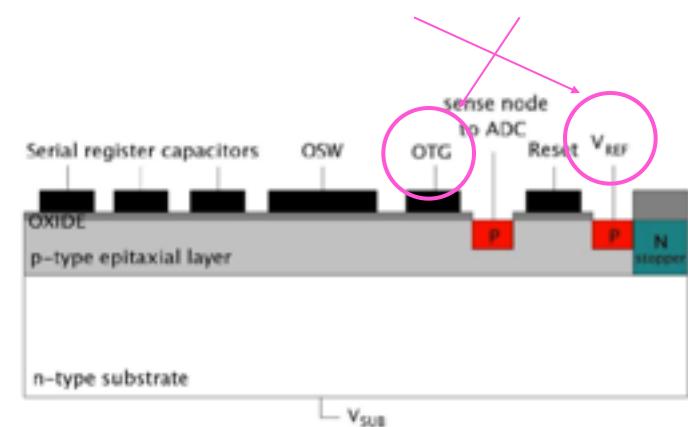


OTG & VOTGSCAN tests

A preliminary test to determine the operation region of the CCD



$$V_{EFF} = V_{REF} - V_{OTG-Cl}$$



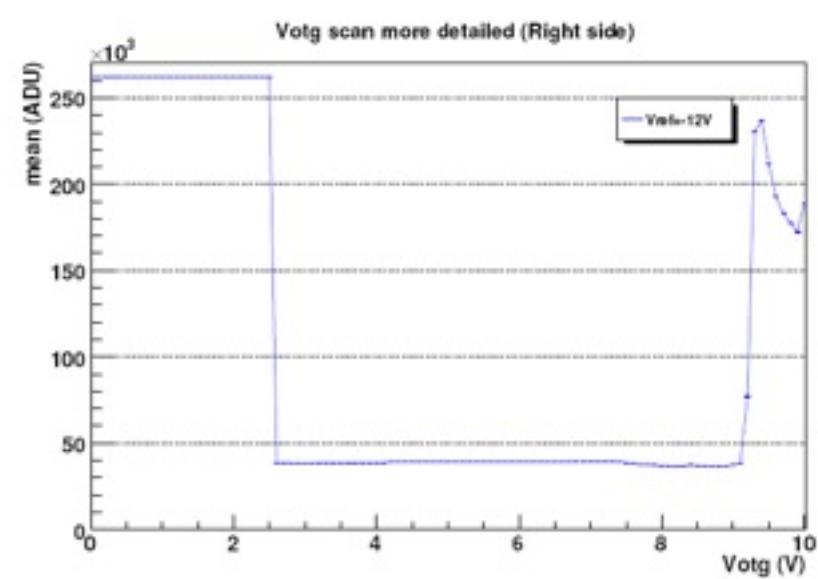
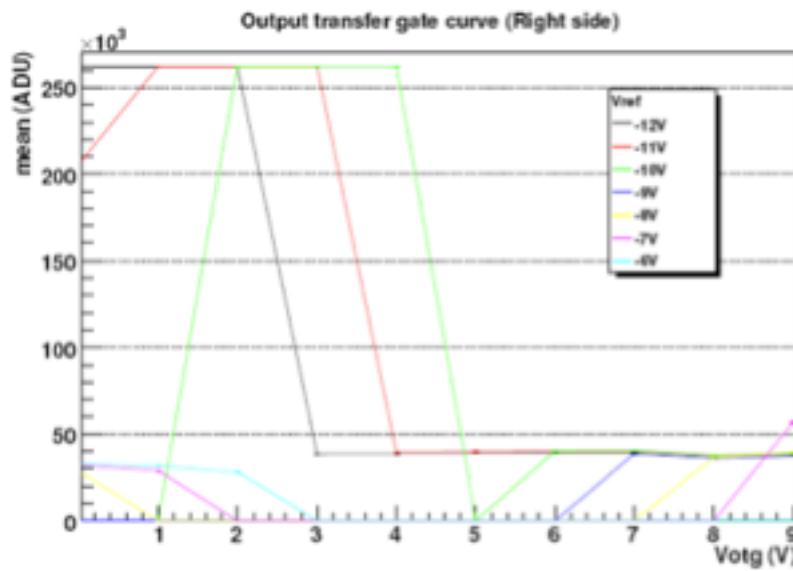
Images: 1 Clear + 20 sec exposed

for each pair (V_{OTG} from 0 to 9V, V_{REF} from -12 to -6V)

Mean signal as a function of V_{OTG} for each value of V_{REF}



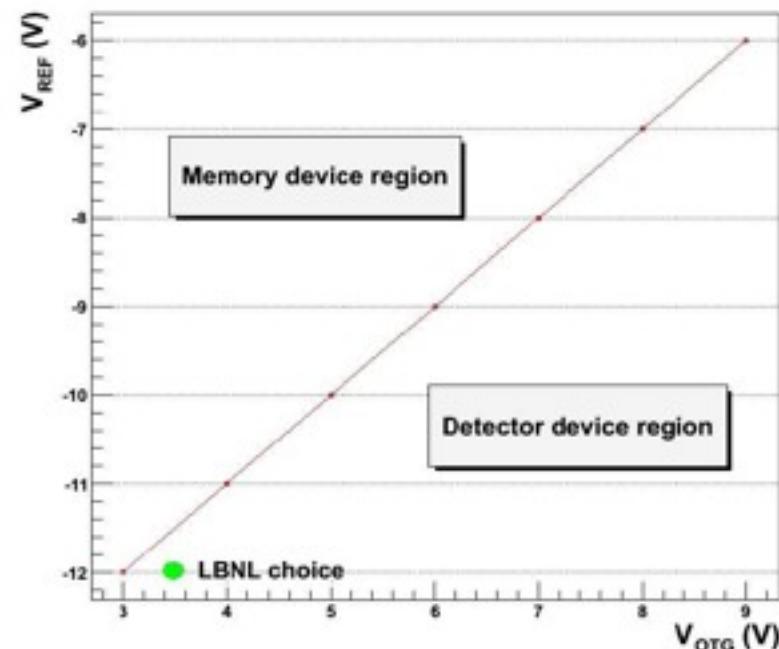
OTG & VOTGSCAN tests



Plots generated.

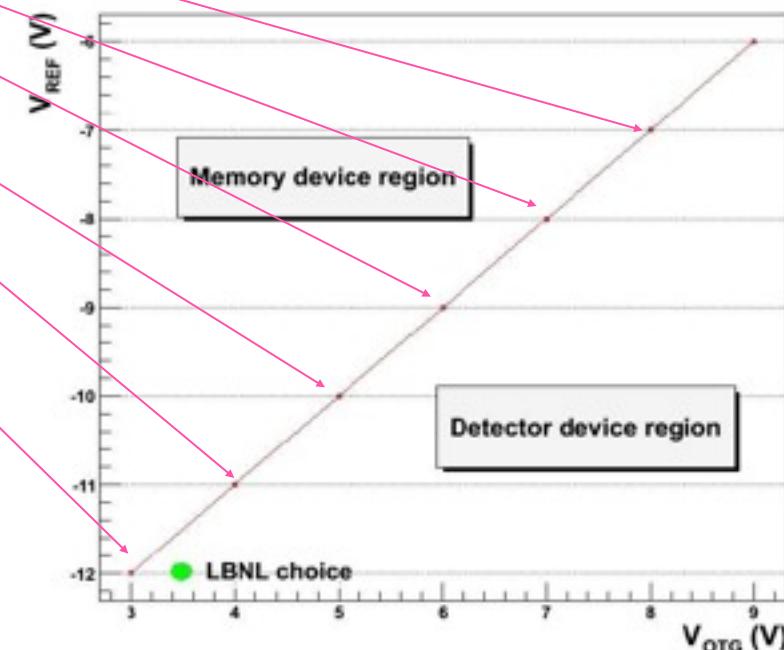
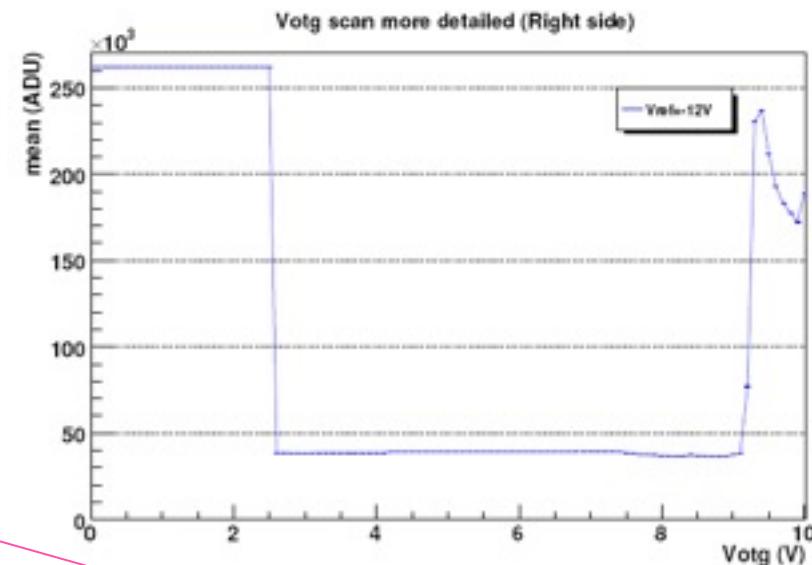
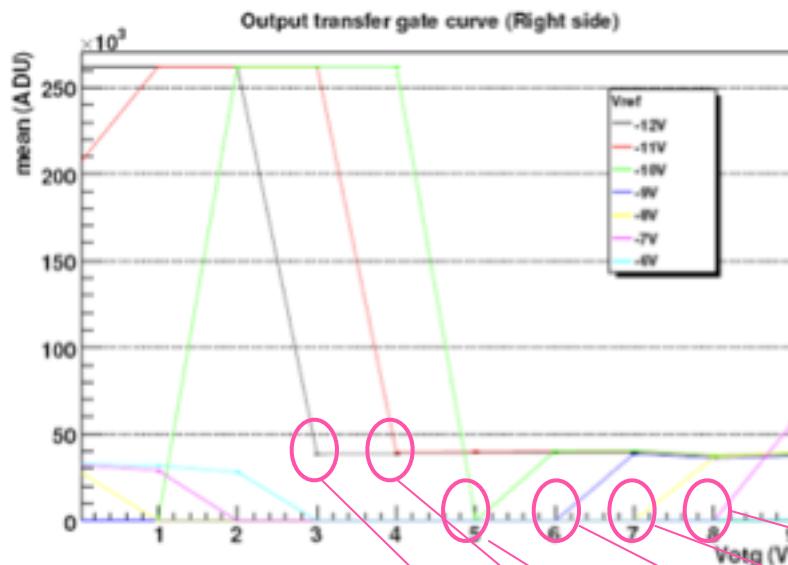
From the values at which the charge injection occurs is plotted the output charge tranfer plot

A new votgscan test is done, fixing V_{REF} to -12V and scanning V_{OTG} each 0.1V





OTG & VOTGSCAN tests



Plots generated.

From the values at which the charge injection occurs is plotted the output charge tranfer plot

A new votgscan test is done, fixing V_{REF} to -12V and scanning V_{OTG} each 0.1V



The photon transfer curve data is used to determine:

- the linearity
- the full well capacity
- the conversion gain (ADU vs electrons)
- pedestal

Signal in a pixel $S(ADU) = PQ_E S_V A_V$

Incident photons emitted (n)
Quantum efficiency (eh/n)
Sense node sensitivity (V/eh)
Amplifiers gain (ADU/V)

Gain: number of electrons needed to produce one ADU

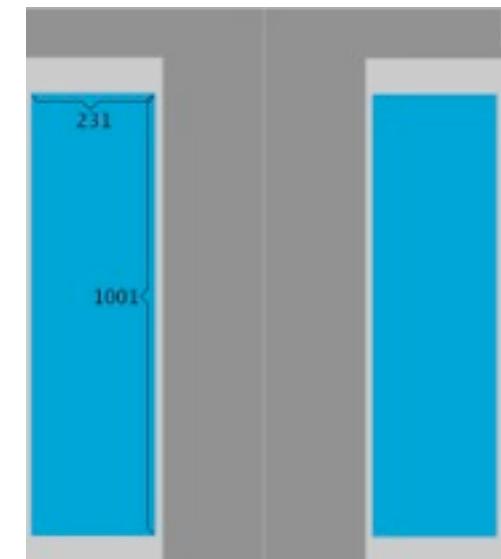
$$K = \frac{1}{S_V A_V} \quad \xrightarrow{\text{Poisson}} \quad K = \frac{S}{\sigma_S^2}$$

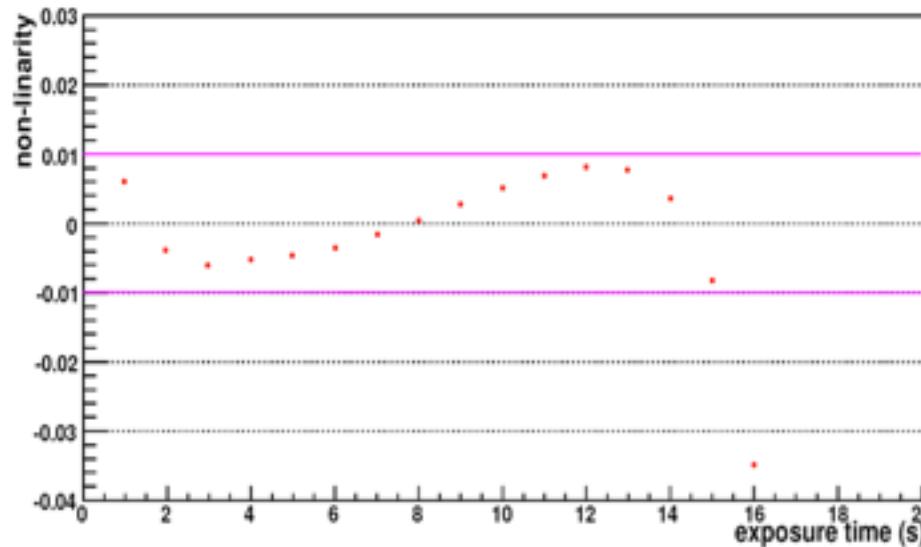
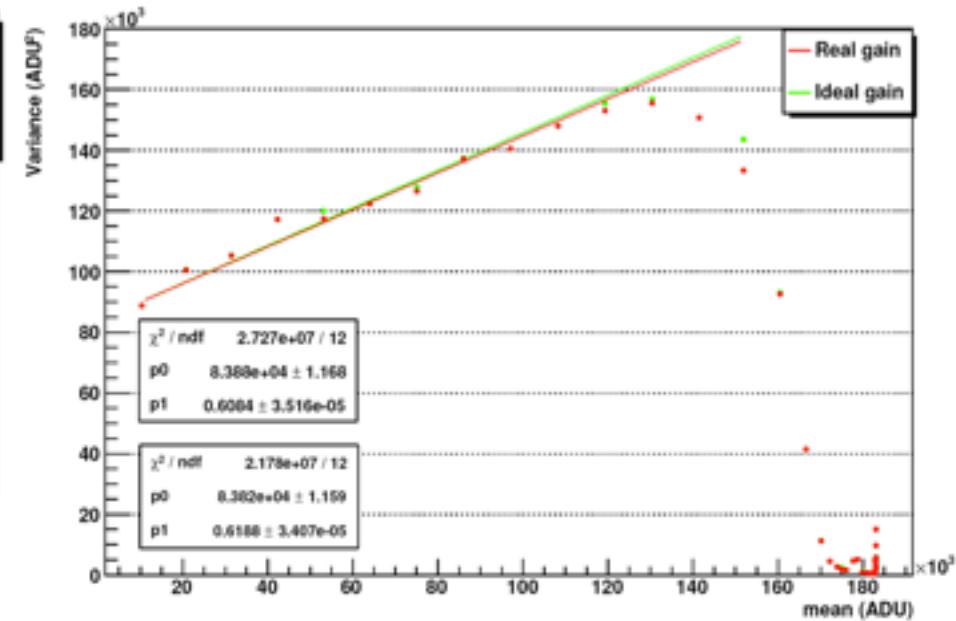
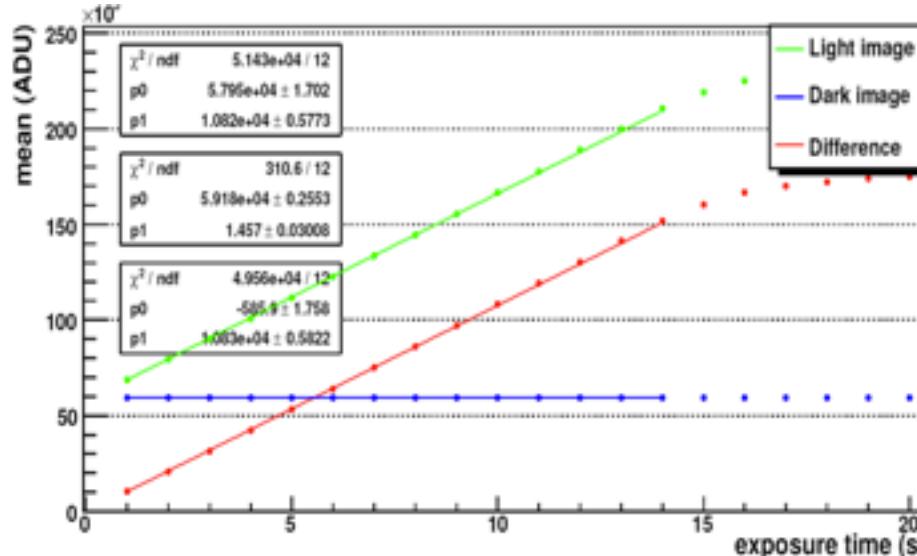
Images: 1 clear + 1 non-exposed + 1 clear + 1 exposed

For each exposure time from 1 to 40 seconds

Mean signal as a function of exp. Time

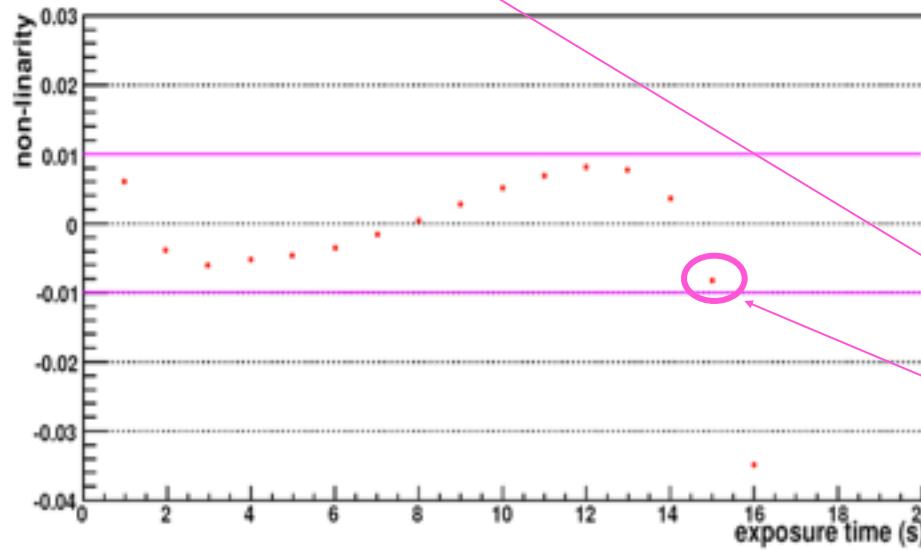
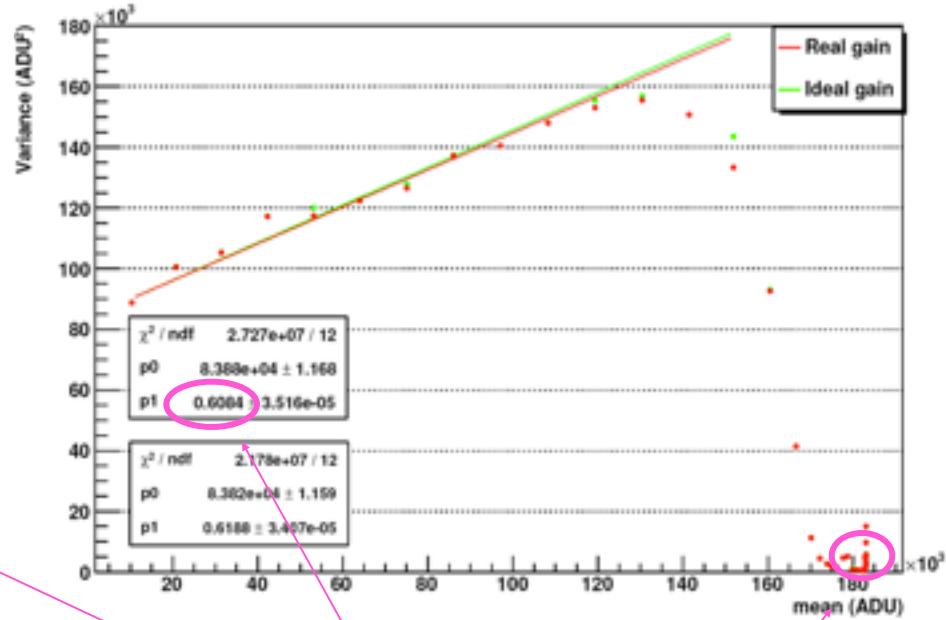
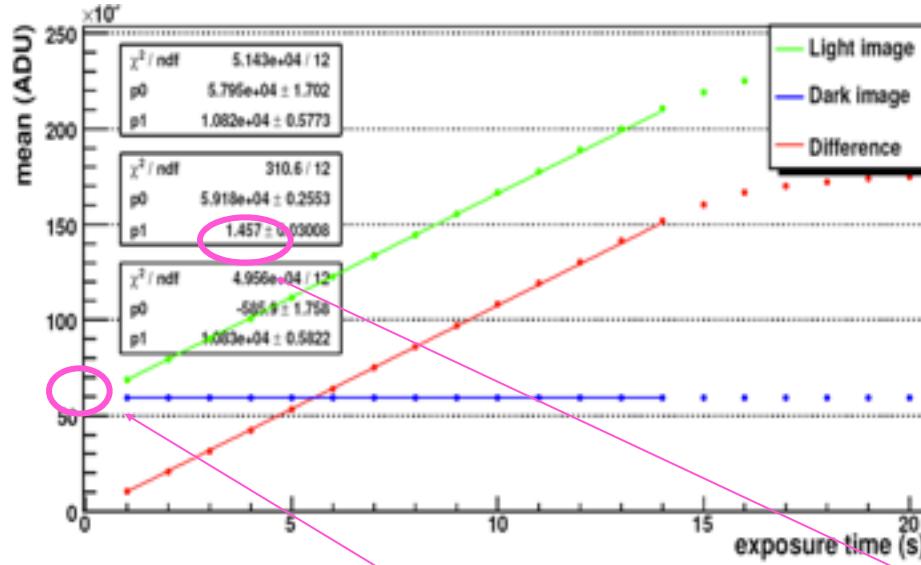
Variance as a function of mean signal





Plots generated:

- Gain measurement
- Pedestal, well capacity & dark current
- Linearity



Plots generated:

- Gain measurement
- Pedestal, well capacity & dark current
- Linearity



Relation between signal in one pixel and the energy loss by a muon

Minimum-ionizing particles (MIP)

$$\begin{array}{l} \text{In Si: } 270\text{eV}/\mu\text{m} \\ \qquad\qquad\qquad \longrightarrow 74 \text{ electrons}/\mu\text{m} \\ 3.65\text{eV/electron} \end{array}$$

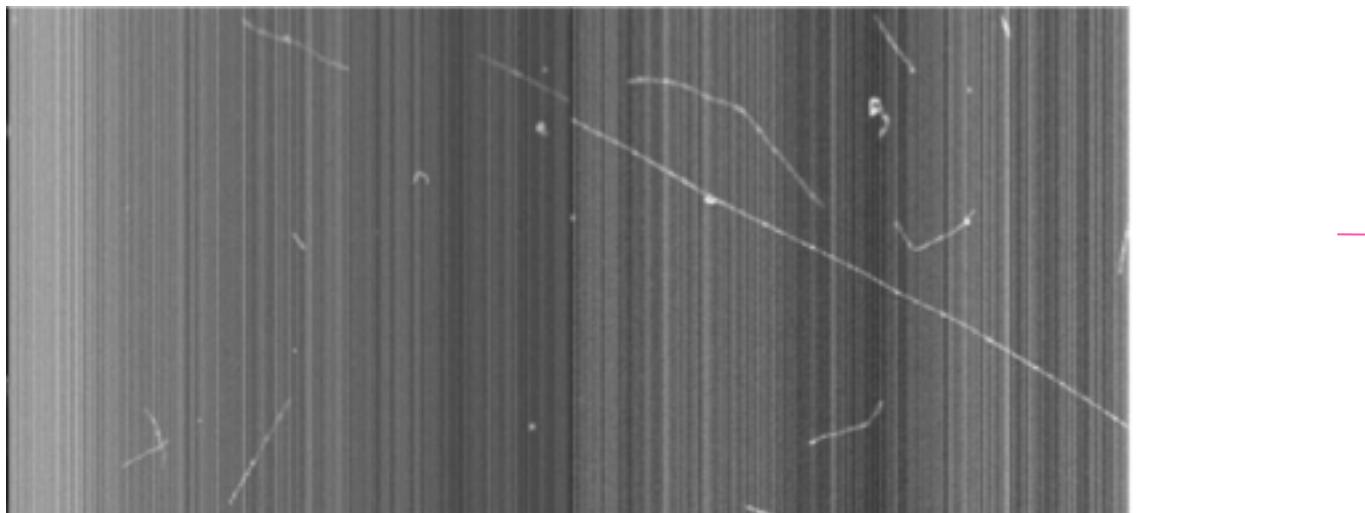
The most probable charge deposition in a $15\mu\text{m}$ of Si, is 1100 electrons

(Maximum of $21.21\mu\text{m}$, 1555 electrons)

100 non-exposed images of 15 seconds, and hope to have good luck!

(+ master dark)

We have to subtract from the signal, the signal in a pixel that was not crossed





Relation between signal in one pixel and the energy loss by a muon

Minimum-ionizing particles (MIP)

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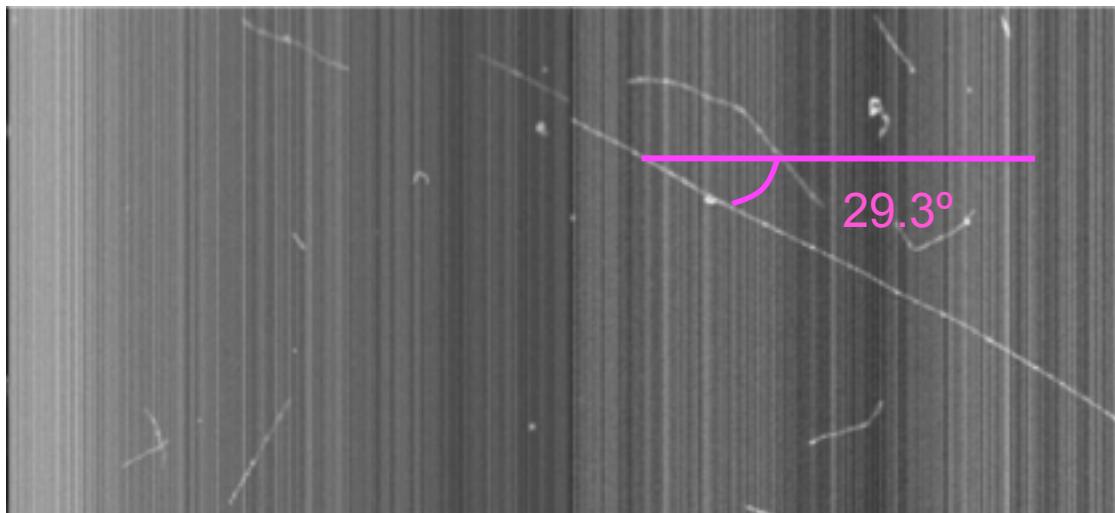
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$17.2\mu\text{m} \rightarrow 1260 \text{ electrons}$
 1408 ADU

$K=0.85 \text{ electron/ADU}$



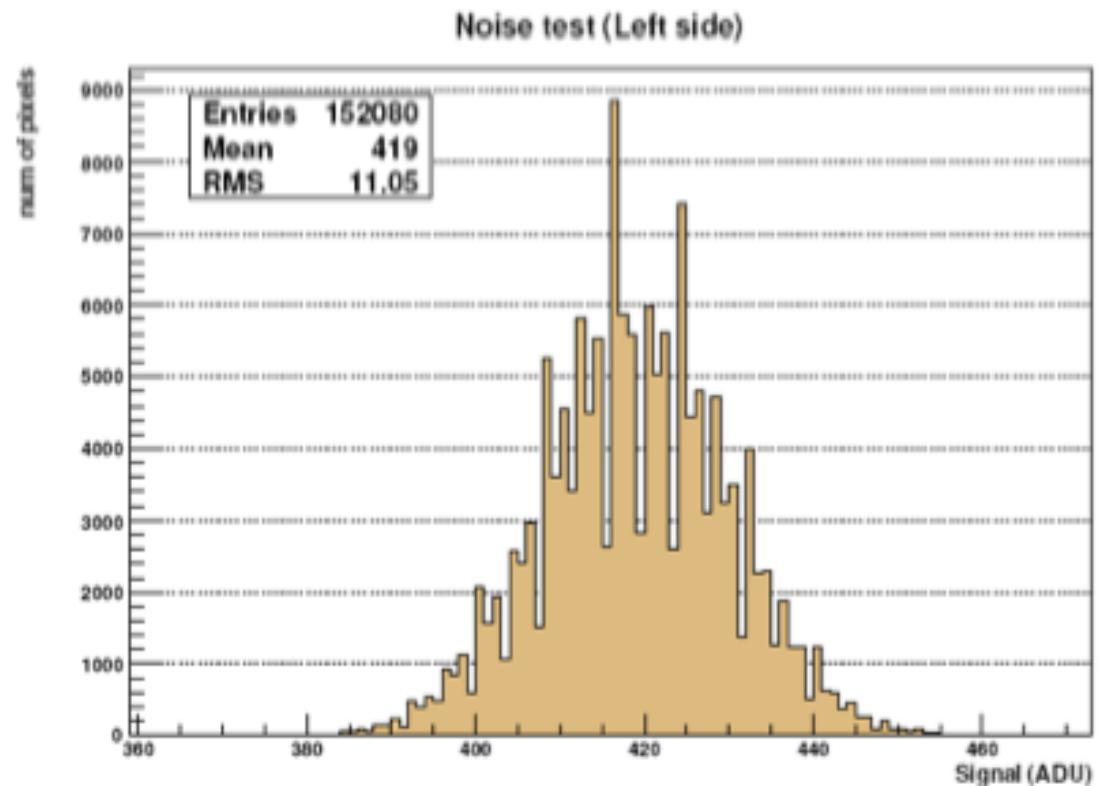
NOISE test

Measure of the noise generated by whole chain: read-out, thermal and shot noise

RMS of the signal distribution of the overscan region

Images: 10 consecutive readings

Average of the noise value
for the 10 images





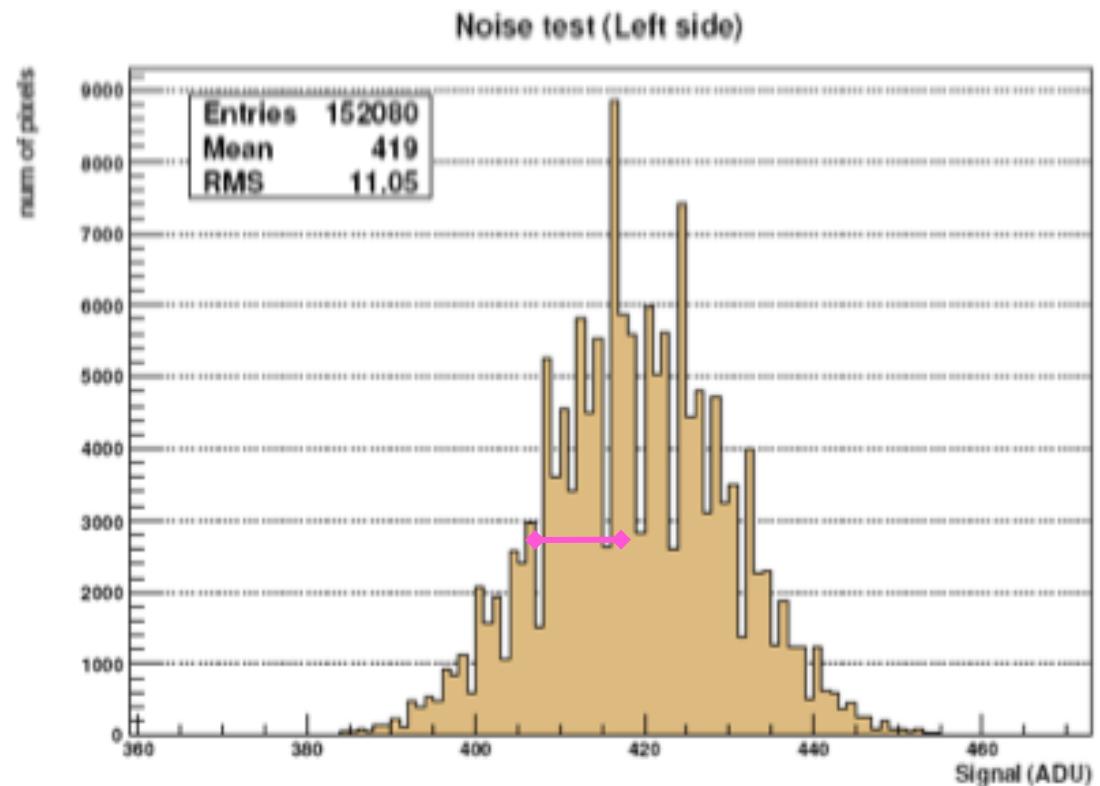
NOISE test

Measure of the noise generated by whole chain: read-out, thermal and shot noise

RMS of the signal distribution of the overscan region

Images: 10 consecutive readings

Average of the noise value
for the 10 images





Proper collection and transfer of charge in the potential wells: **Charge Transfer Inefficiency**

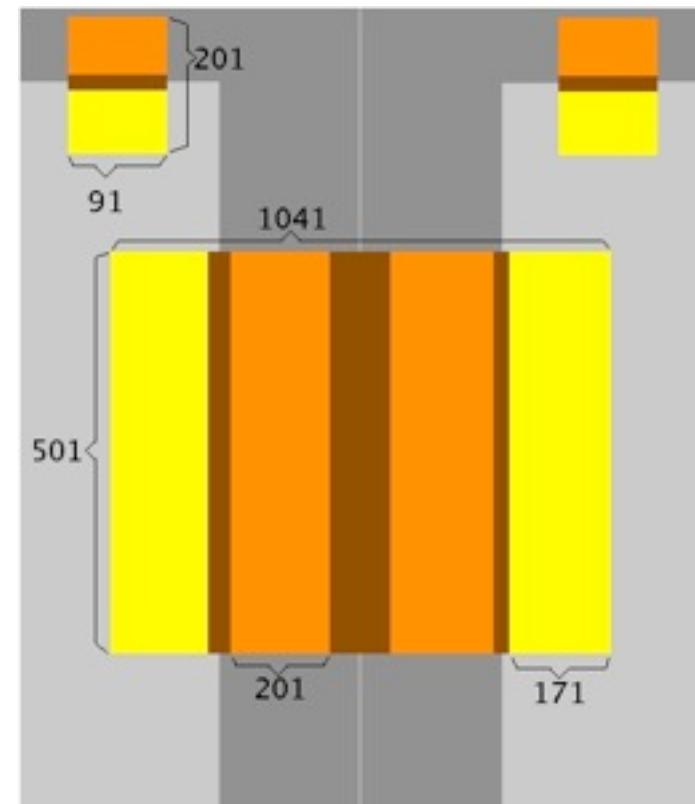
4 subtests, one for each value related with the transfer process (H+/H-/V+/V-)

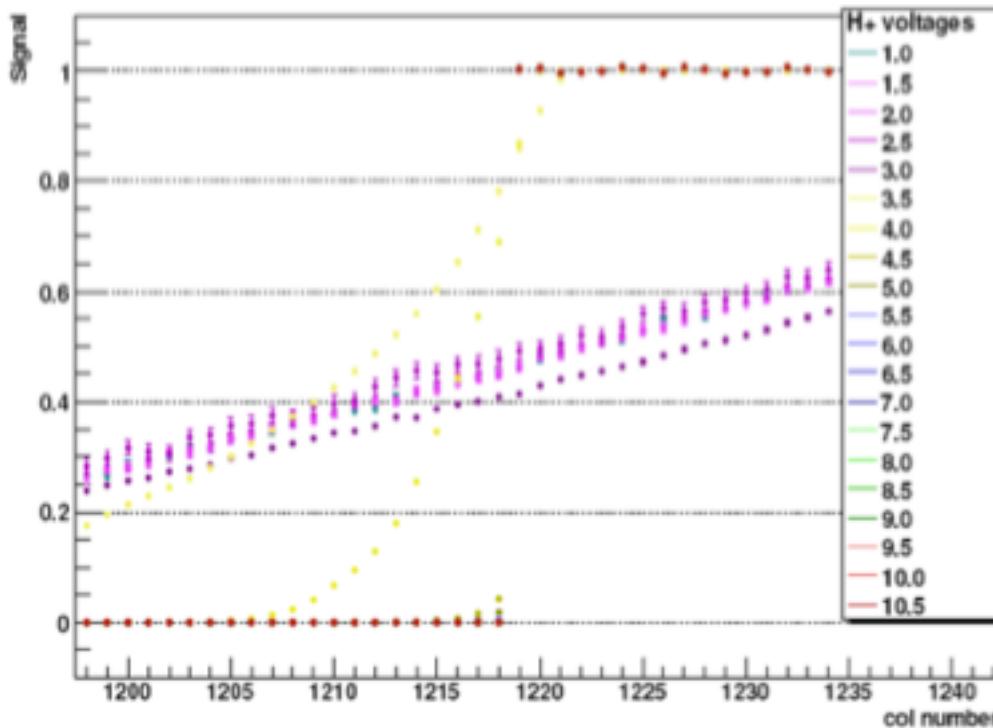
$$S_i = \frac{\mu_{col,i} - \mu_{pedestal}}{\mu_{mean} - \mu_{pedestal}}$$

$$CTI = \frac{S_{i,last.col}}{256}$$

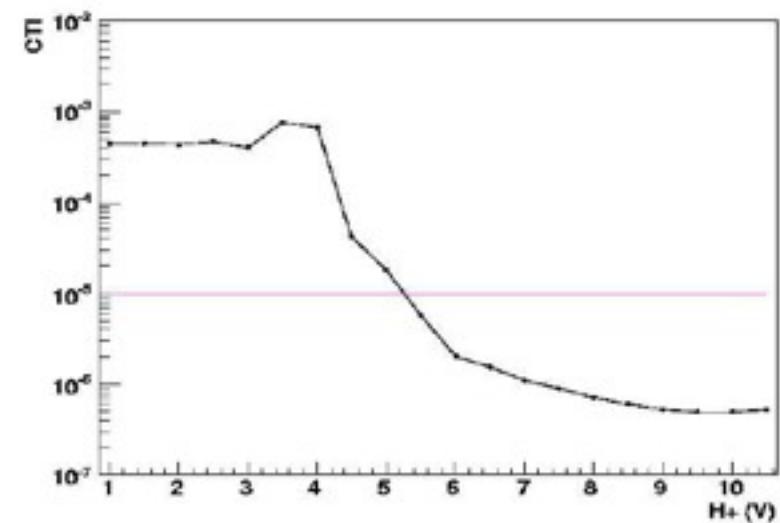
Images: 1 clear + 10 sec exposure
For each subtest, increasing 0.5V the appropriate voltage

Mean signal by columns in the transition to overscan region
CTI and noise is measured in each image

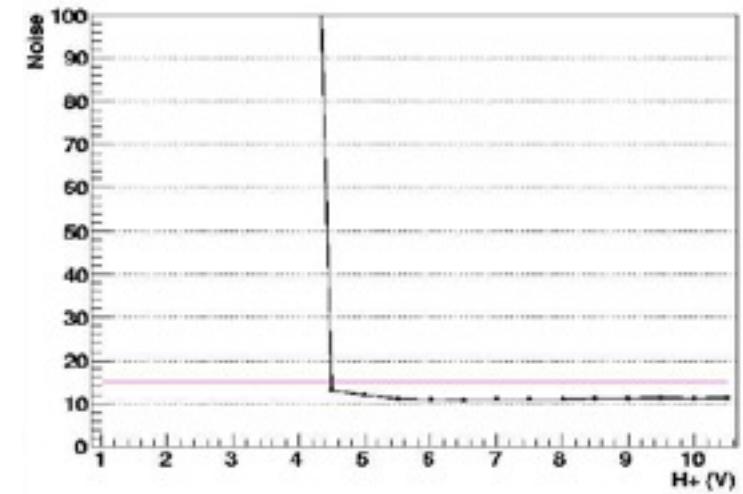


H⁺ example

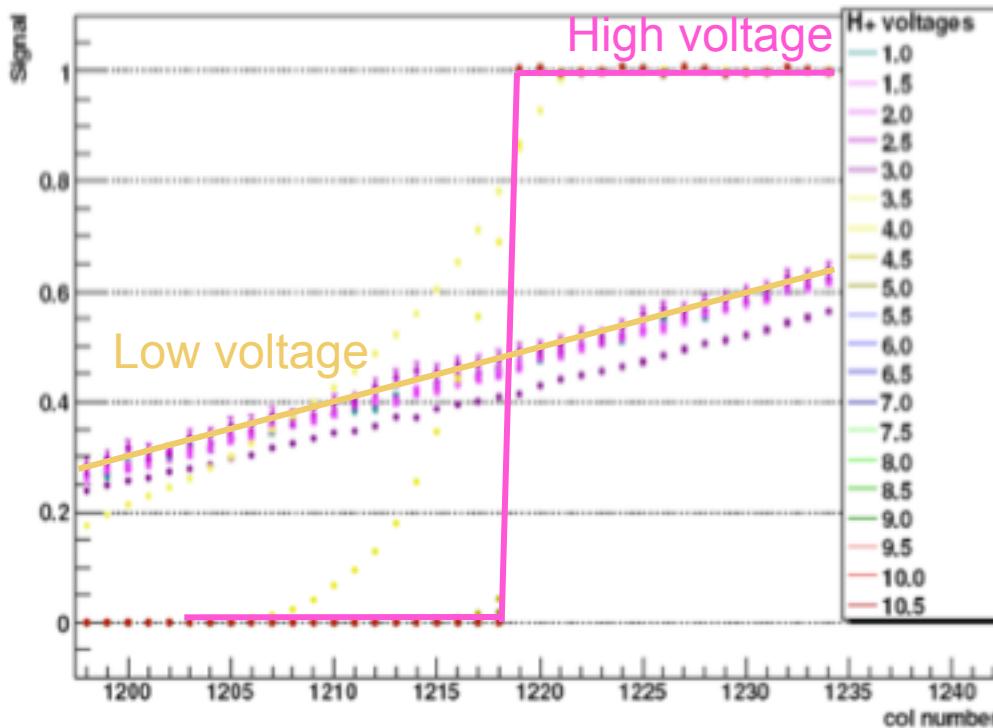
Increasing the voltage of H⁺, the CTI improves



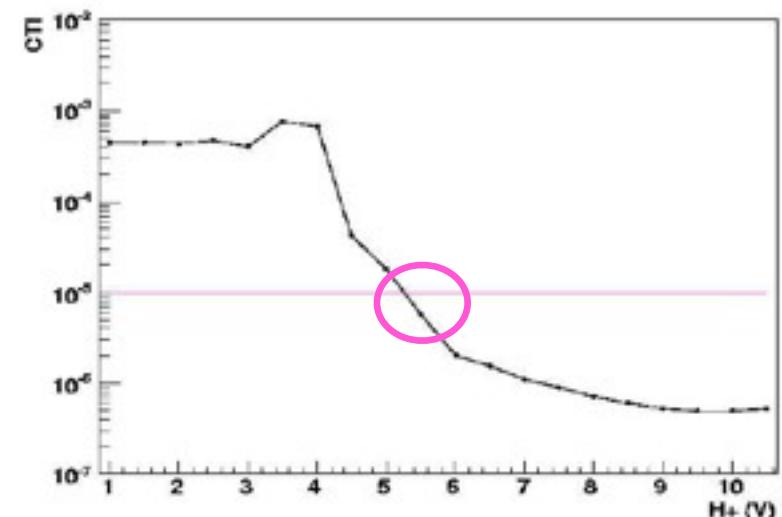
At some value the requirement is achieved



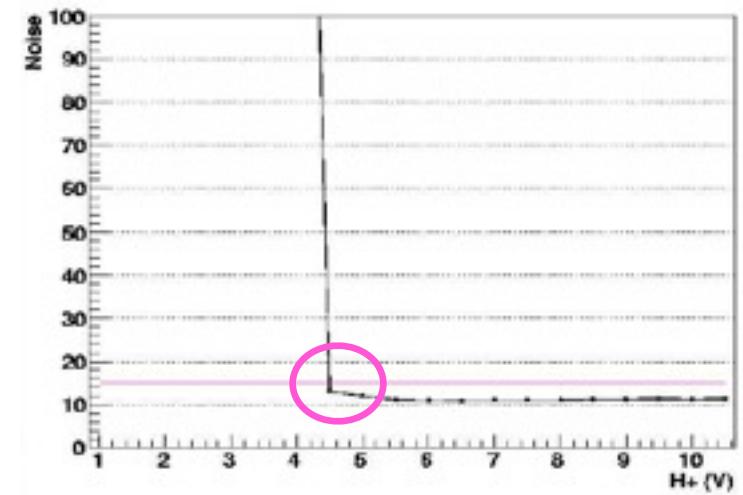
For low voltages the noise is too high

H⁺ example

Increasing the voltage of H⁺, the CTI improves



At some value the requirement is achieved



For low voltages the noise is too high



An alternative method to measure both the gain and the CTI

A source placed 2 cm in front of the CCD

GAIN

^{241}Am source used

Signal distribution

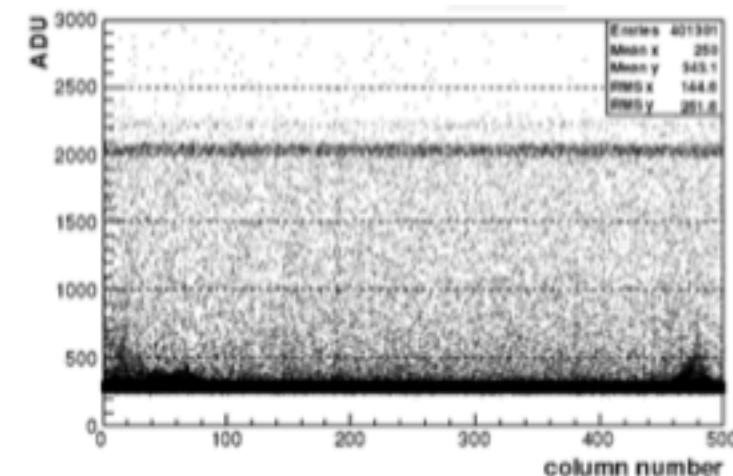
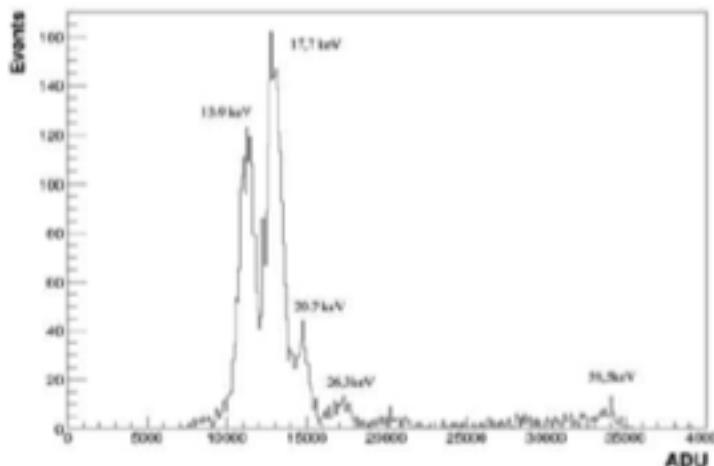
10 images of 10 second exposure

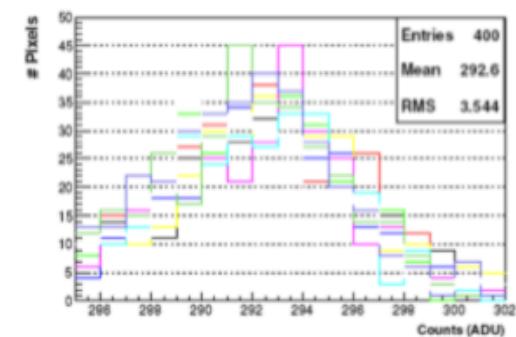
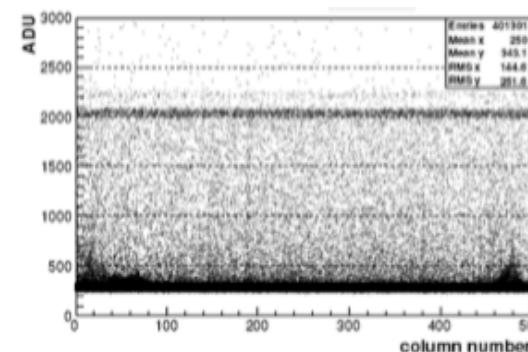
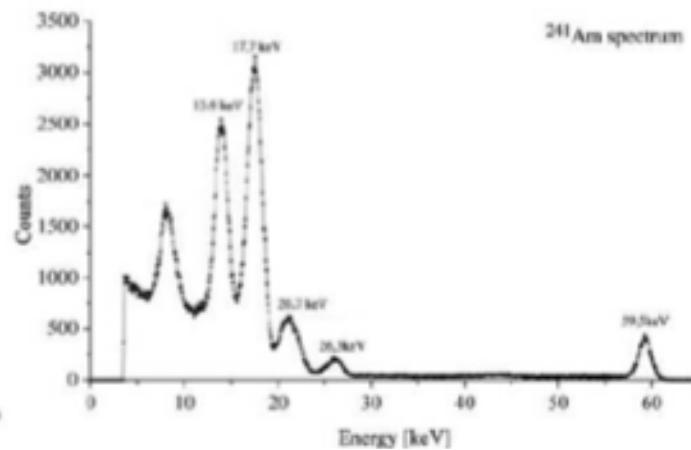
CTI

^{55}Fe source used

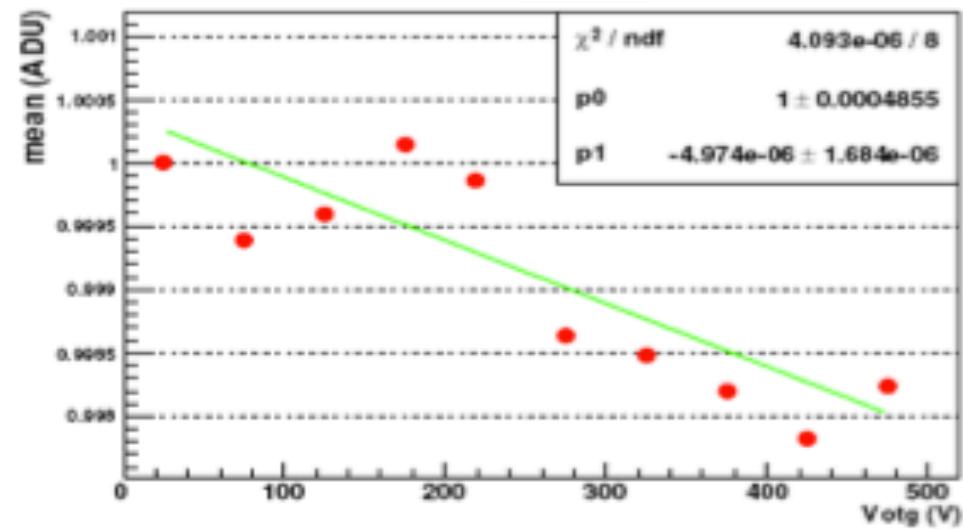
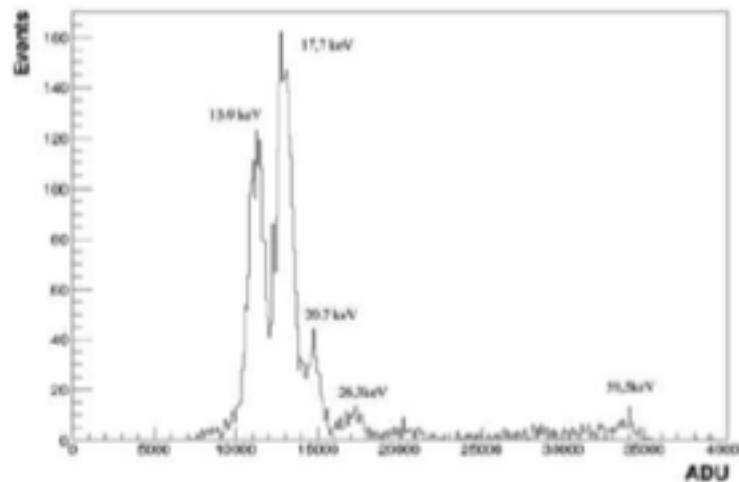
Histogram by columns

10 images of 10 seconds exposure



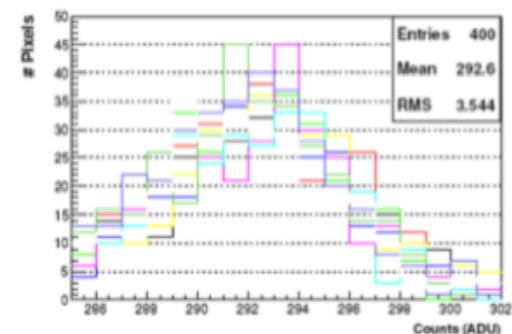
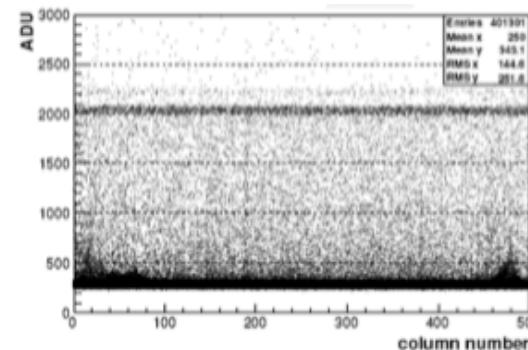
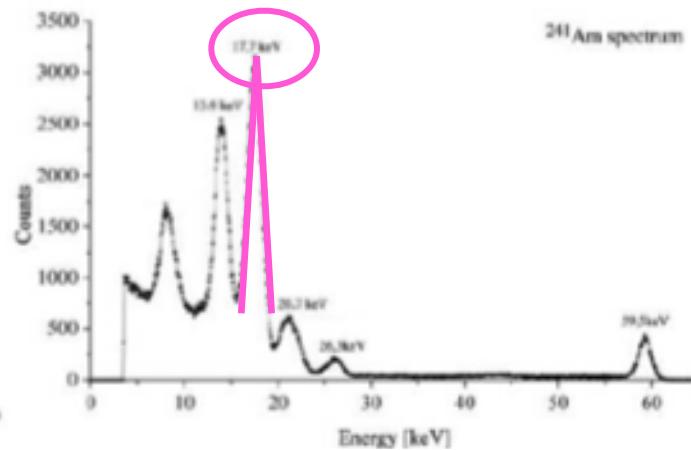


We plot the signal distribution for each 50 columns (in colors)

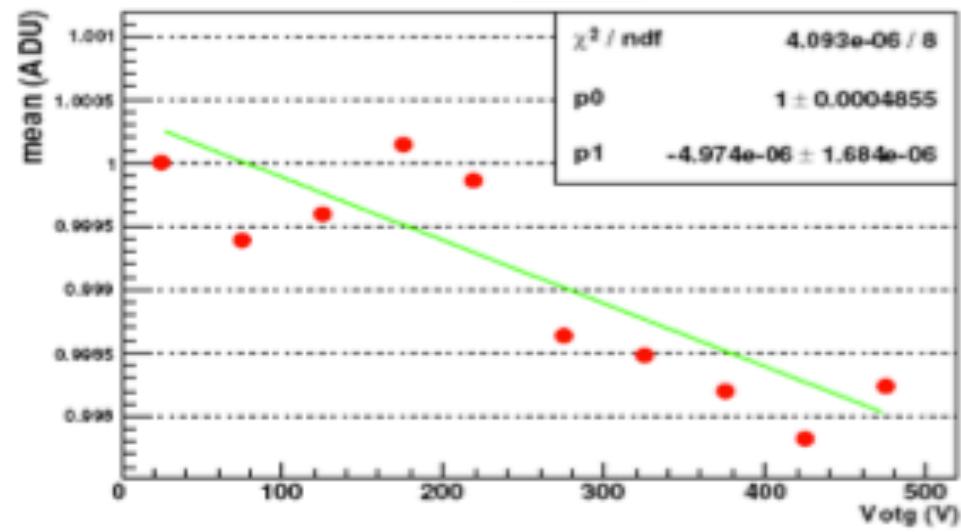
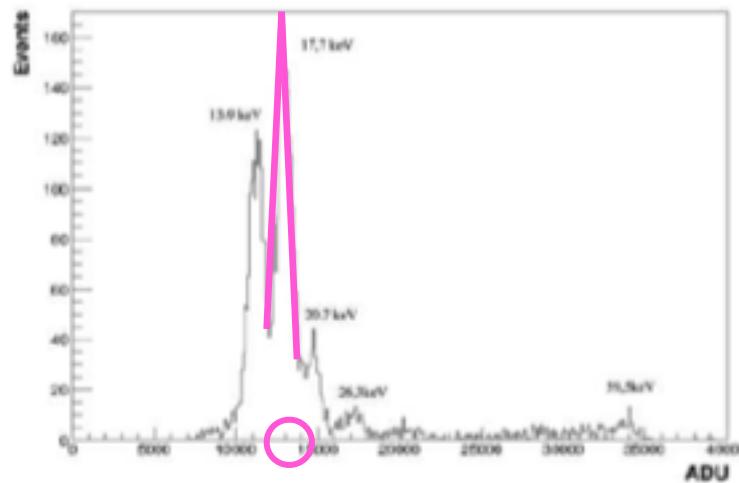


We can compare the number of ADUs of the peaks, with the energy of the peaks in the spectrum of the source (subtracting pedestal)

We take the mean value of the $K\alpha$ of each distribution
And normalize all to the first one
The slope is the CTI

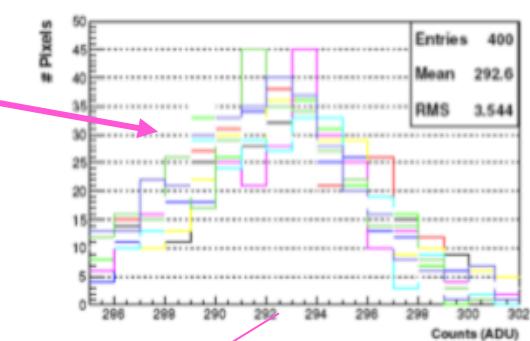
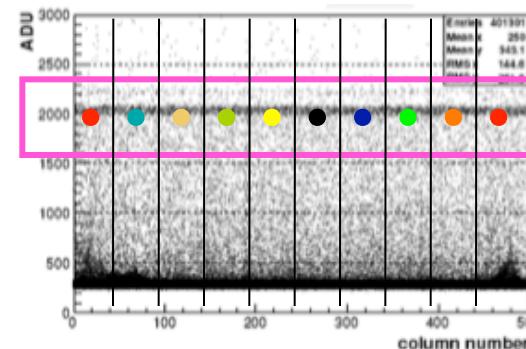
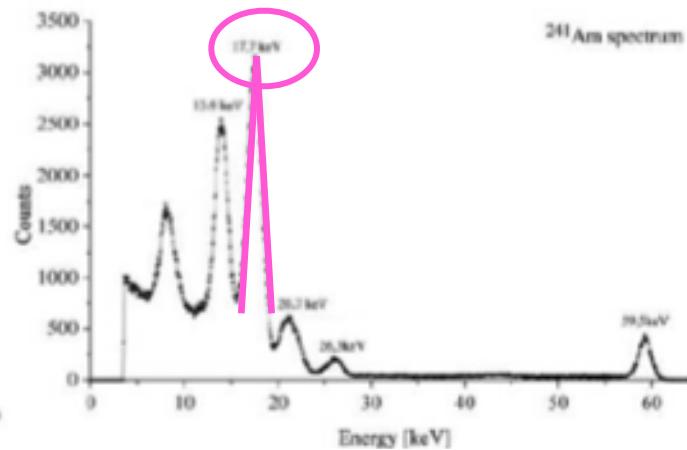


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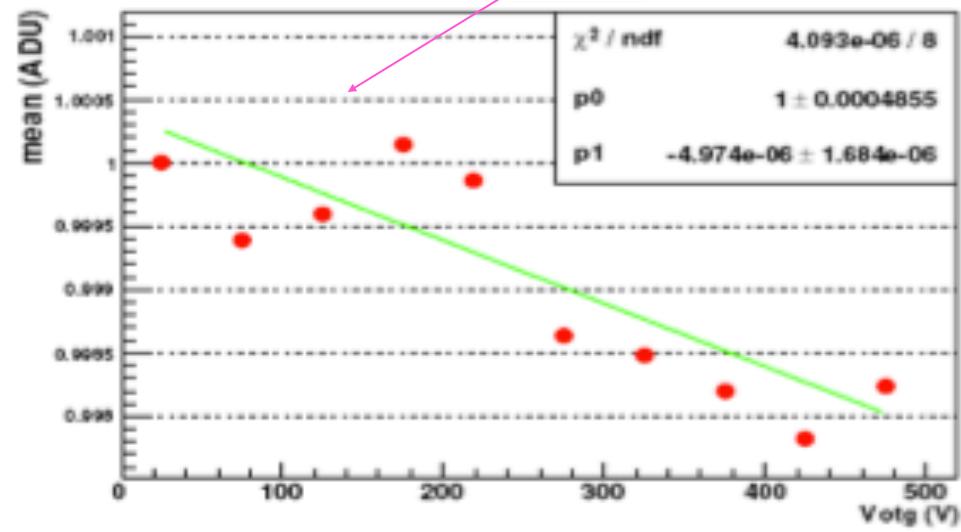
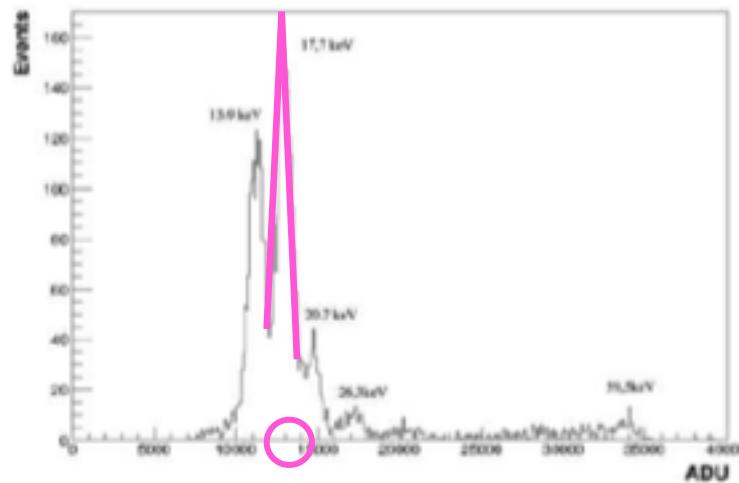


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DARK ENERGY
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Conclusions

- We have developed a test station in IFAE lab to perform tests to the DES CCDs
- We have an automated way to take the set of images for the tests
- We have learned how a CCD test station works, and now we are able to be a CCD test station for DES and other projects